

Beamline Design for Imaging

M. Strobl

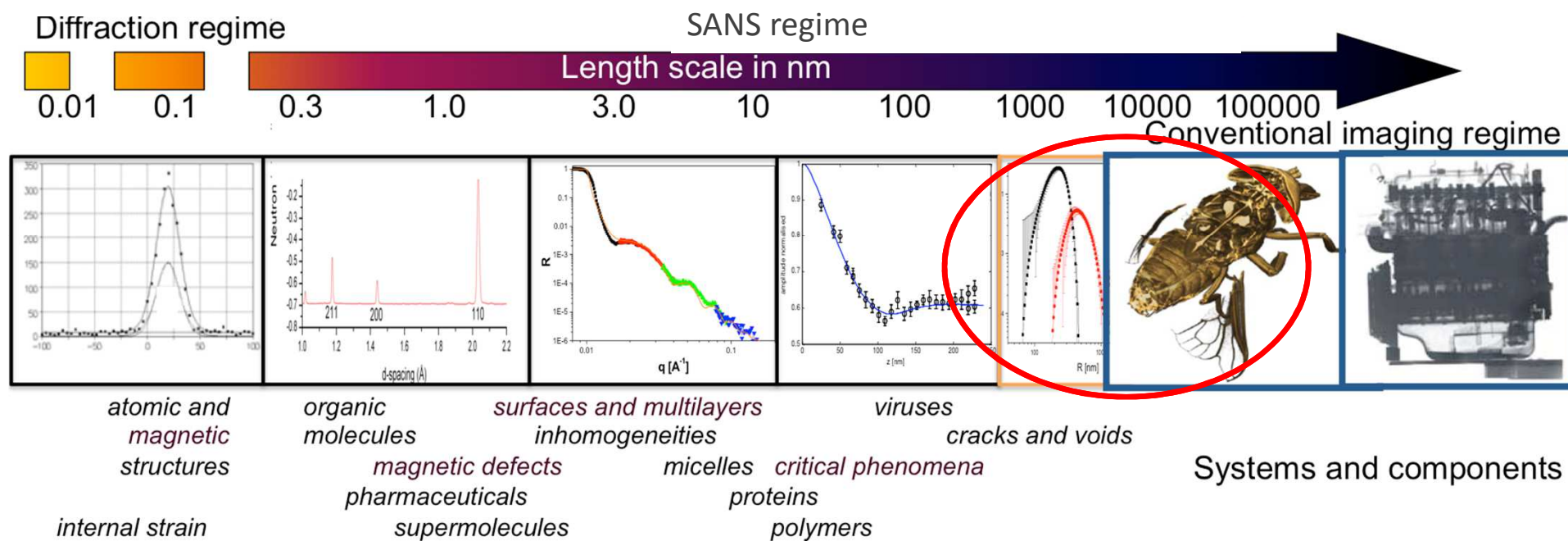
Deputy Head of Instrument Division

Prof. X-ray and Neutron Imaging Techniques (NBI, KU)

www.europeanspallationsource.se

AUNIRA Sept. 2015





BASIC

- Imaging Geometry
- Basic Imaging Requirements
- Beam Conditioning: Source to Detector
- Standard Imaging Instrumentation (continuous source)

ADVANCED

- + Scattering, Diffraction and Polarized Neutrons
- + Additions to Basic Instrumentation: Wavelength Resolution
- + Instrumentation for a Time-of-flight Approach
- + Imaging Instrumentation at Pulsed Sources

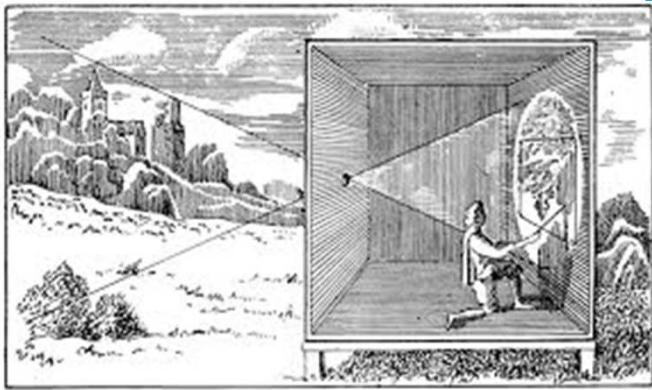
Basics



No optics



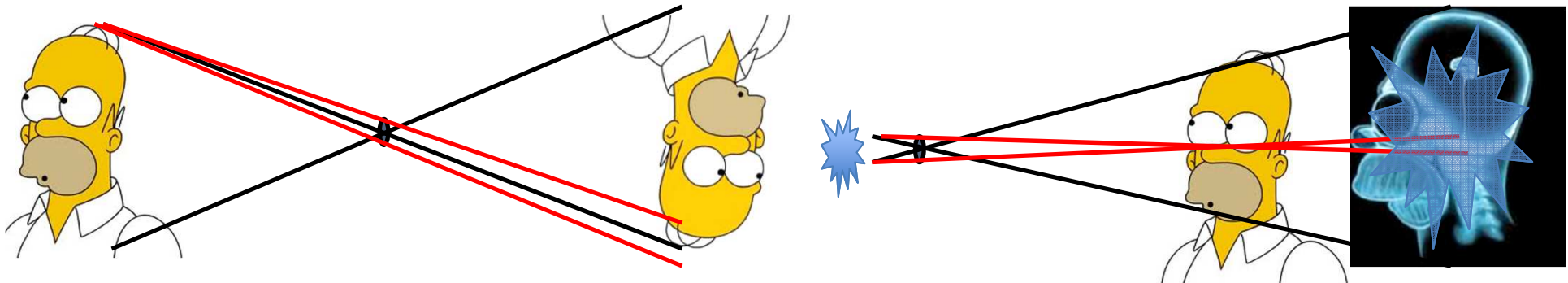
Basics – Imaging Geometry



Camera obscura



No optics



But spatial resolution!
Clearly a condition for imaging!

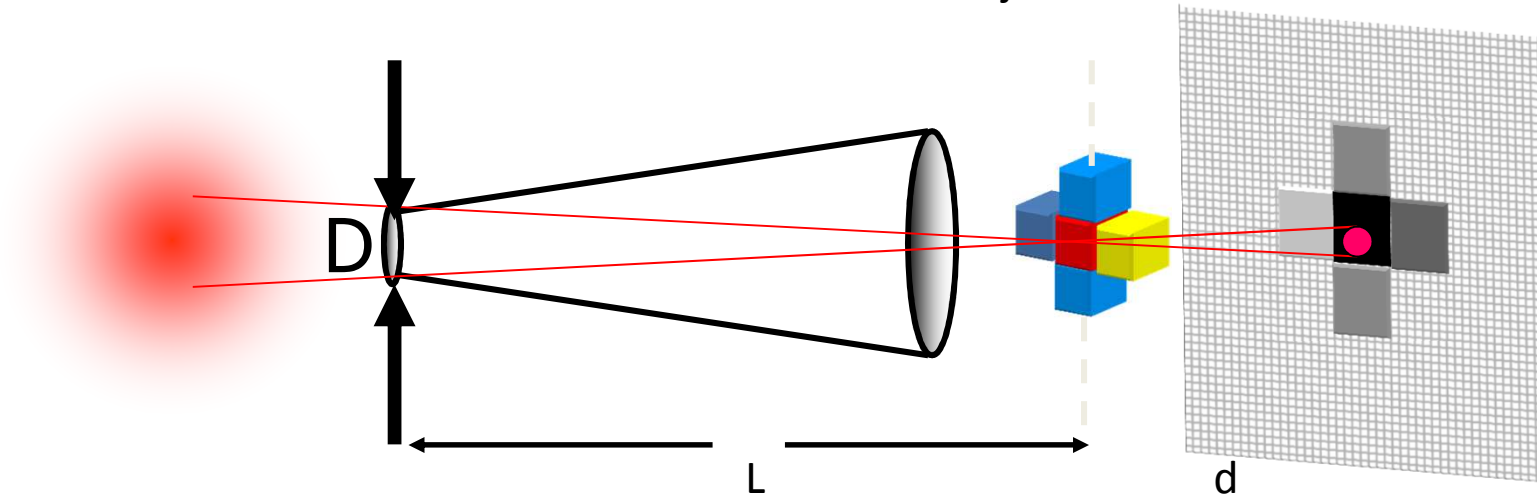
Basics – Imaging Geometry

Source

Collimator

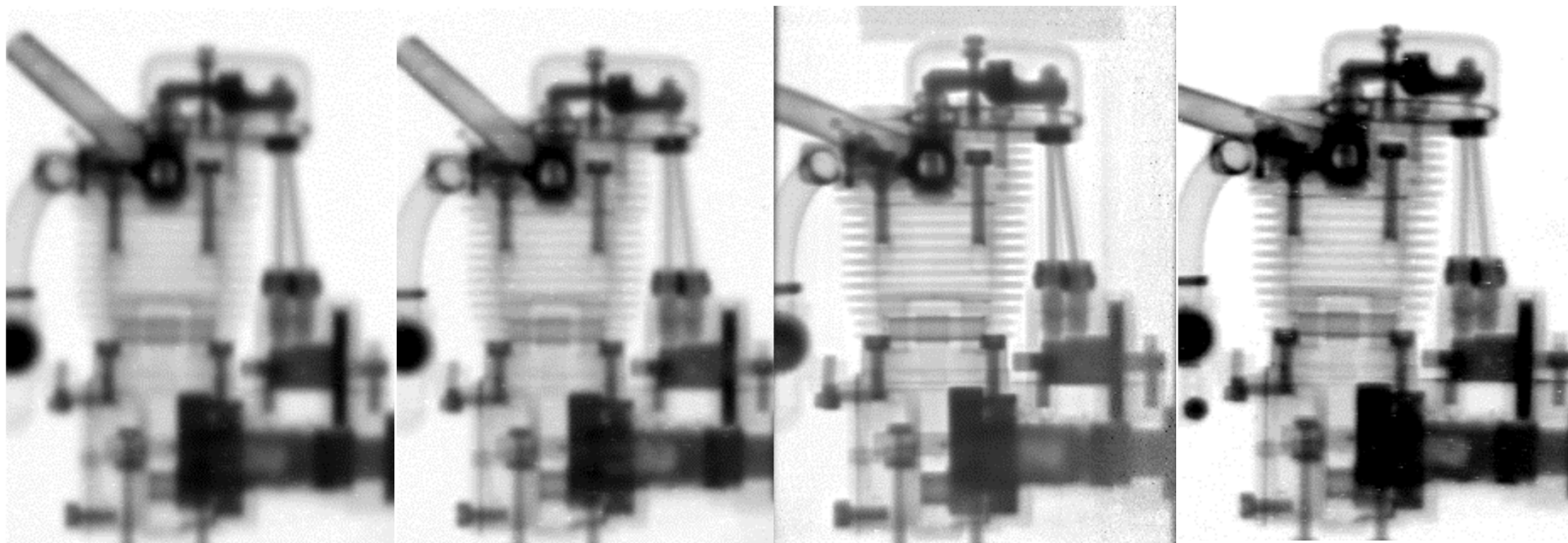
Object

Detector



collimation **blur** ratio $b = \frac{d}{L/D}$ typical: several 100

Basics – Imaging Geometry



$L/D=71$

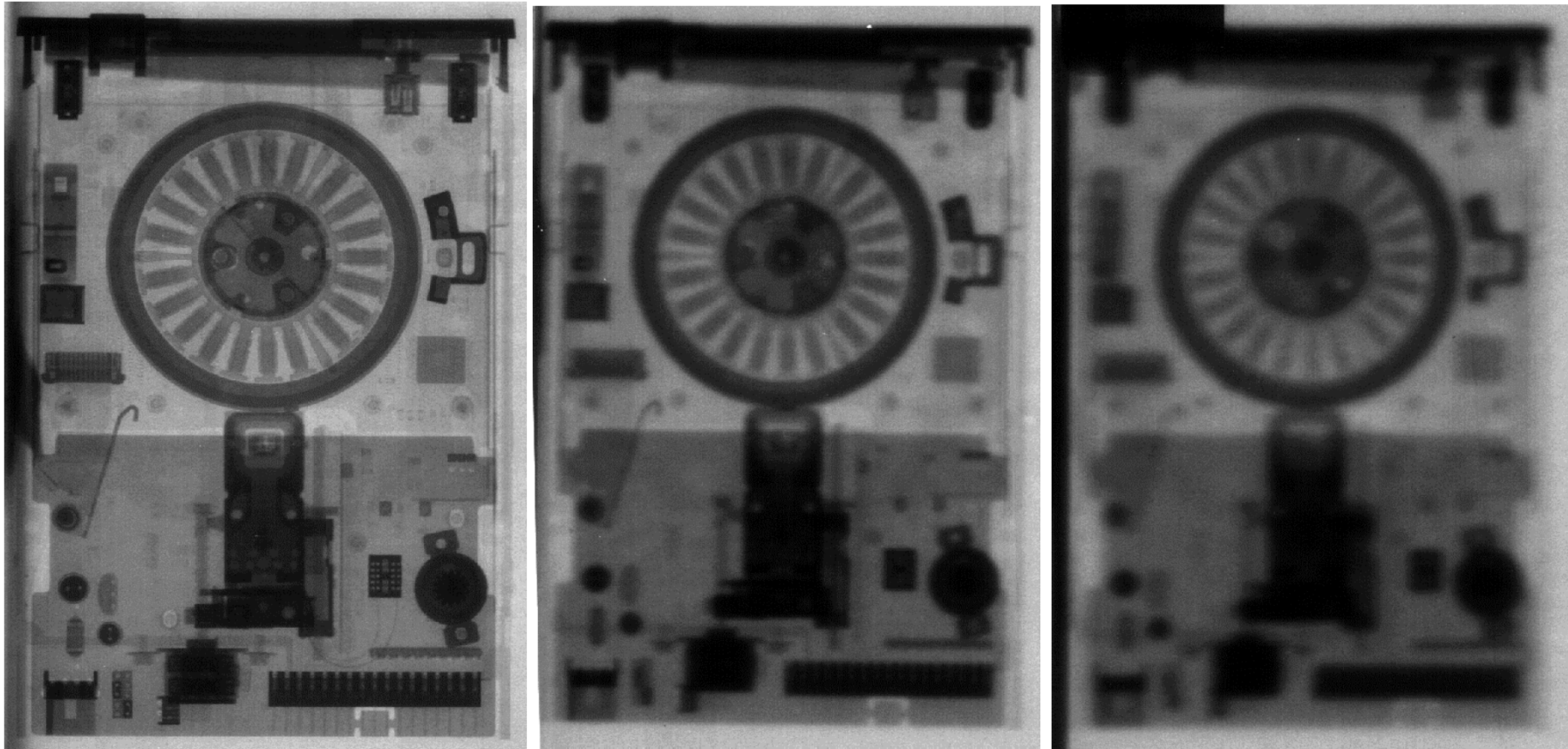
$L/D=115$

$L/D=320$

$L/D>500$.

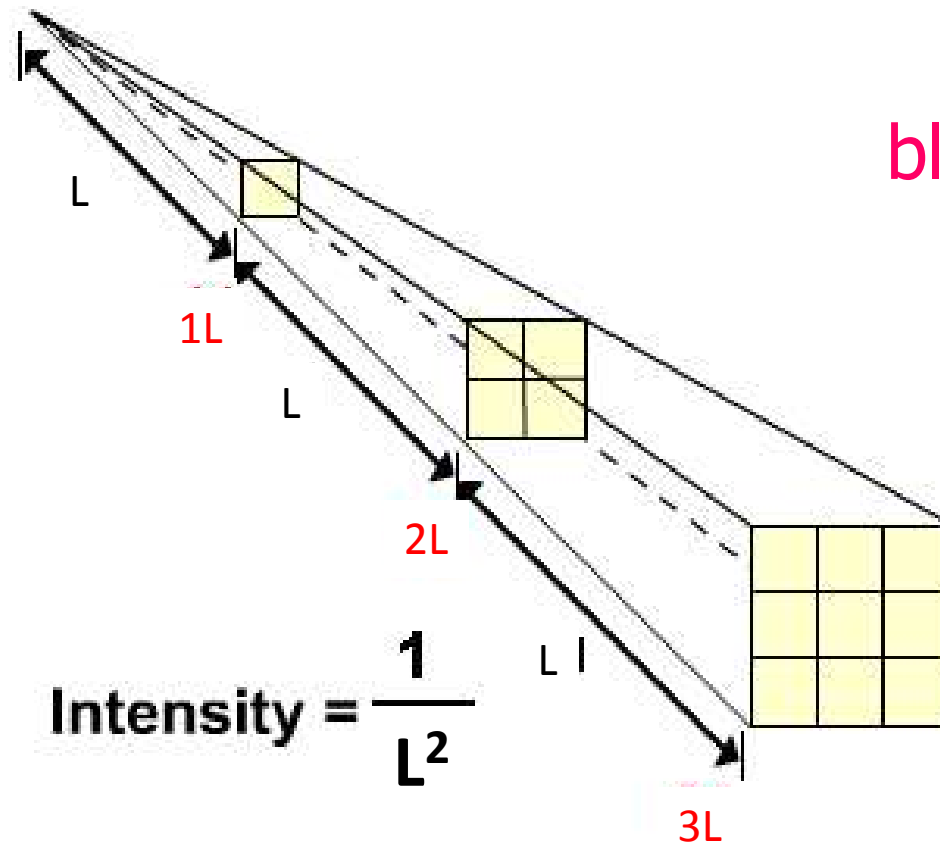
Radiographs of a small motor taken at different beam positions
with different L/D ratios.

Basics – Imaging Geometry



Radiographs of a 3,5" floppy drive in 0 cm, 10 cm and 20 cm distance from a film + Gd sandwich taken at a cold neutron guide with $L/D=71$.

Basics – Imaging Geometry



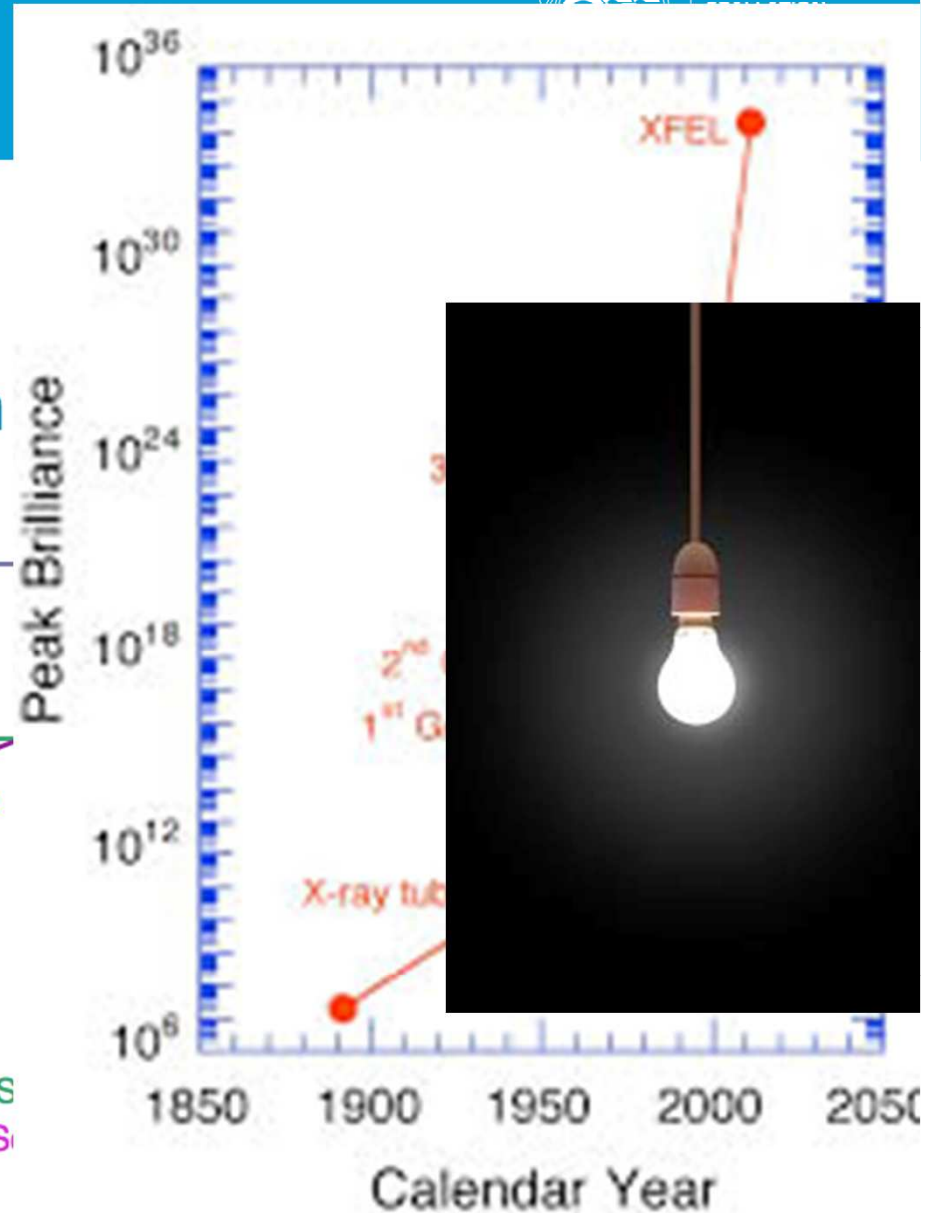
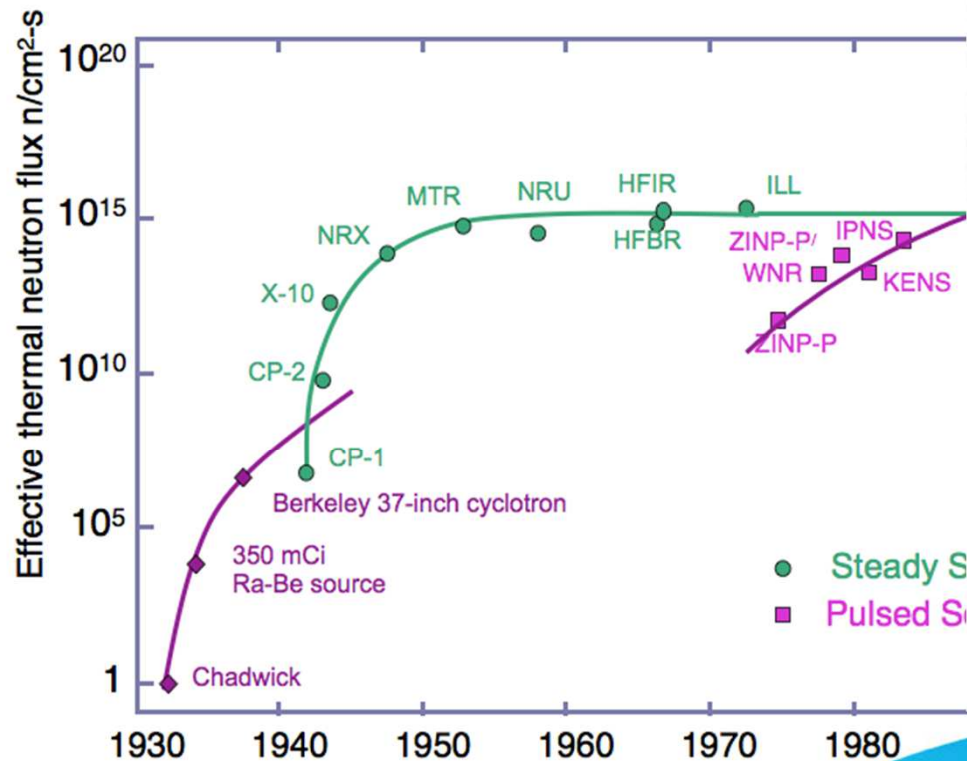
$$b = \frac{d}{L/D}$$

Basics



EUROPEAN
SPALLATION
SOURCE

Evolution of Neutron



Lens – dan hussey

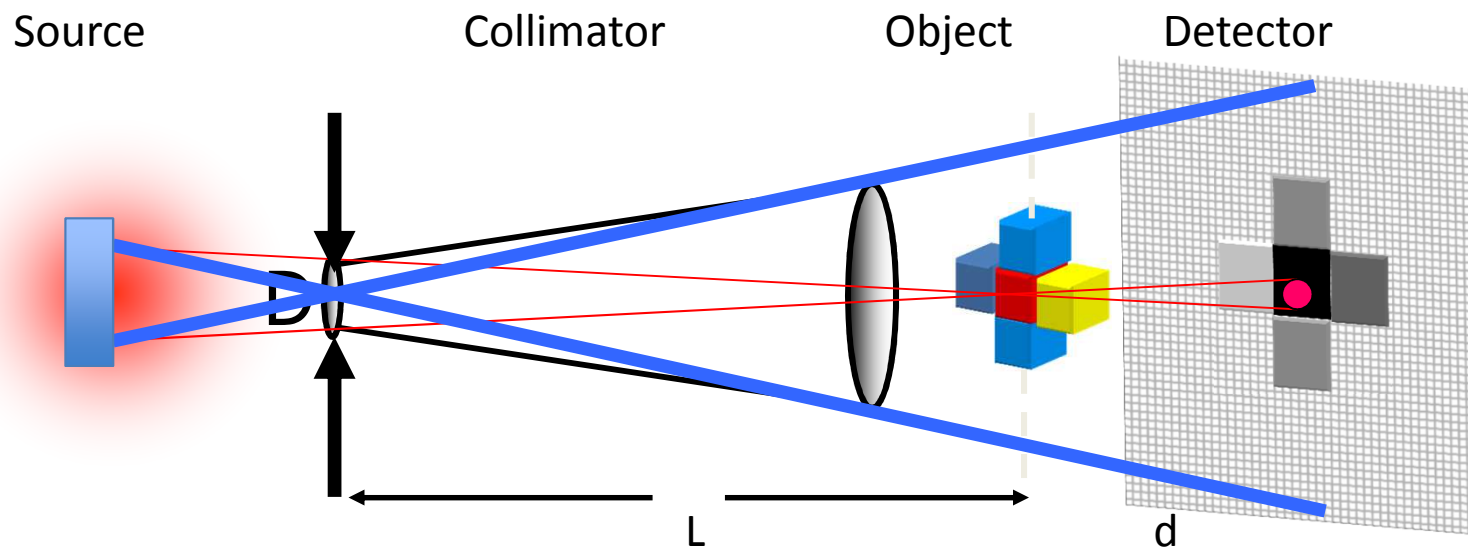
Basic Requirements



- Requirements:
- high flux
 - large well defined FOV
 - spatial homogeneity
 - spectral homogeneity
 - large detector
 - fast detector
 - high resolution detector
 - save shielding

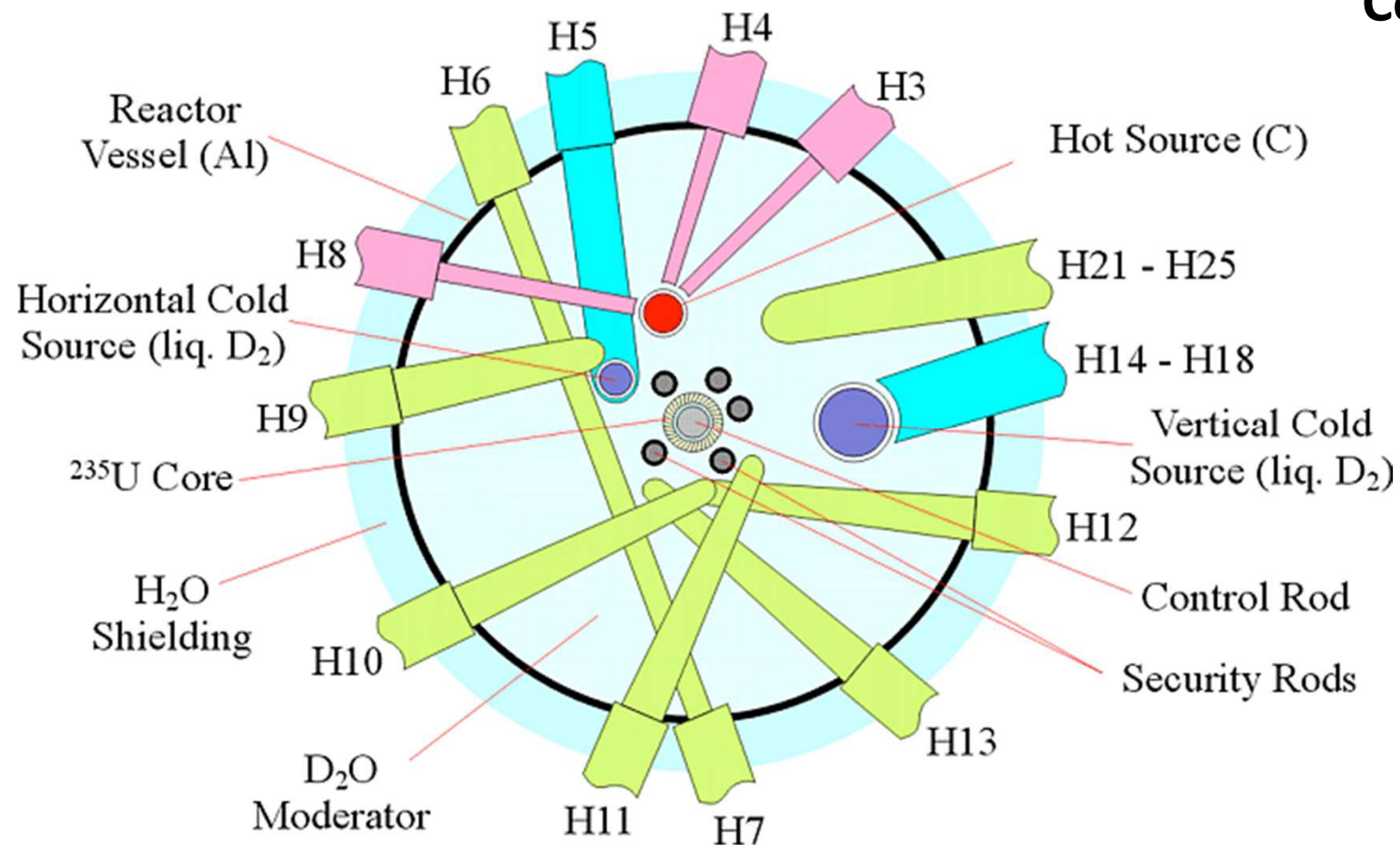
Beam Conditioning: Source to Detector

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 - spectral homogeneity
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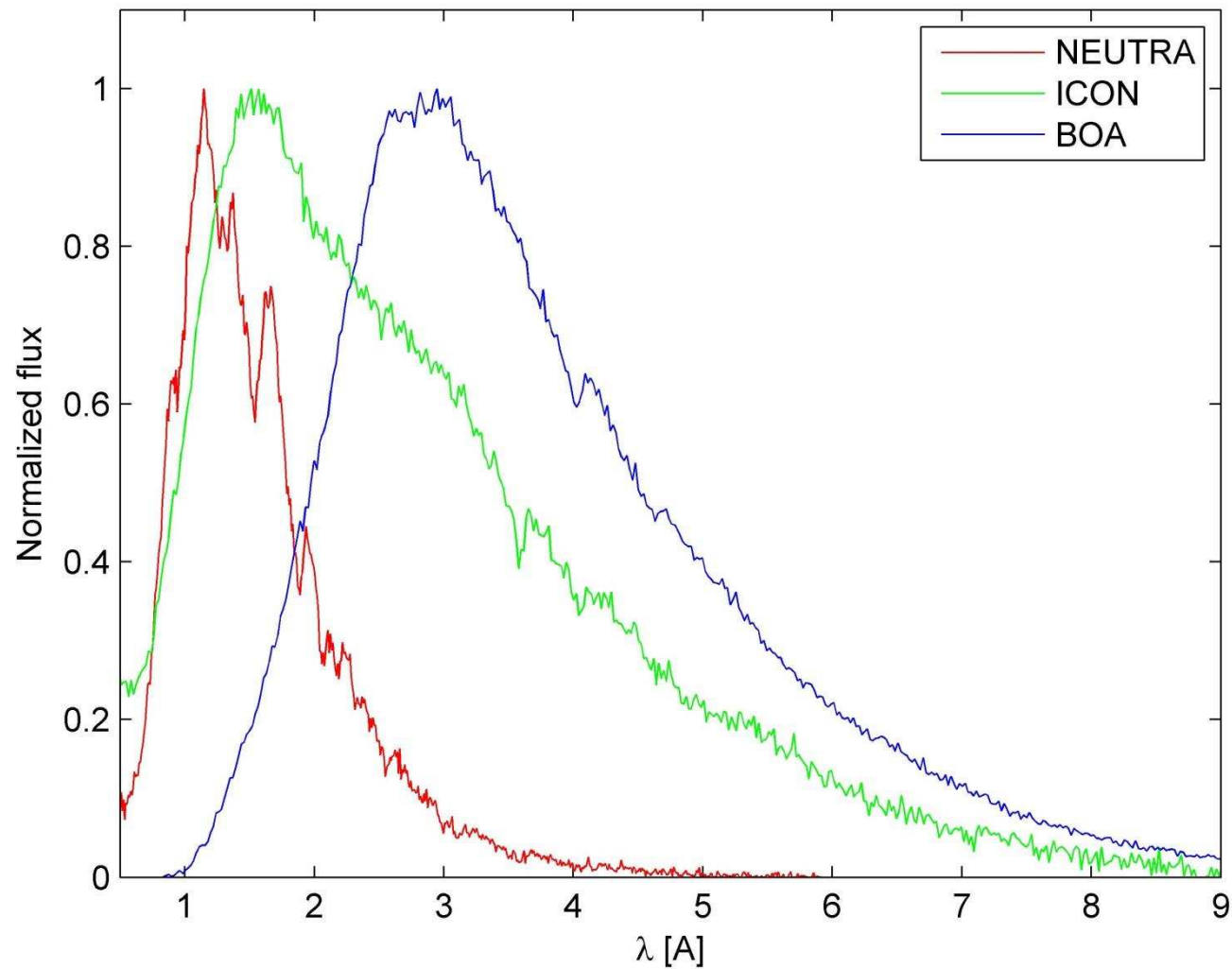


Beam Conditioning: Source to Detector

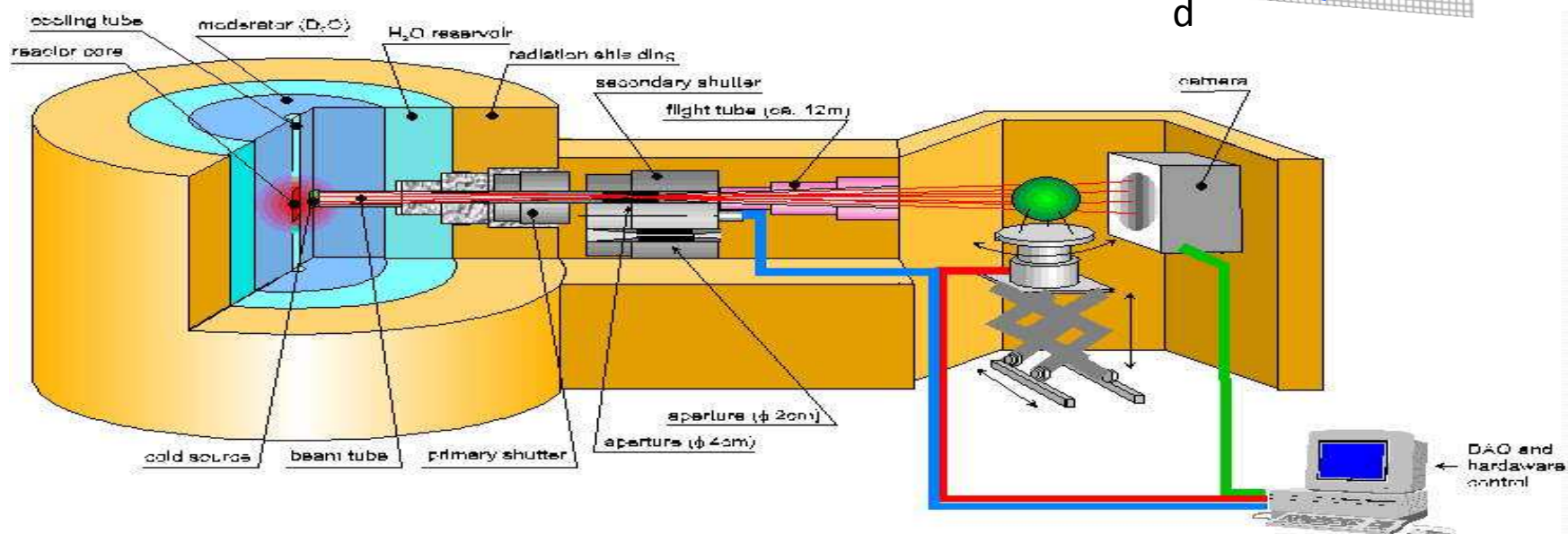
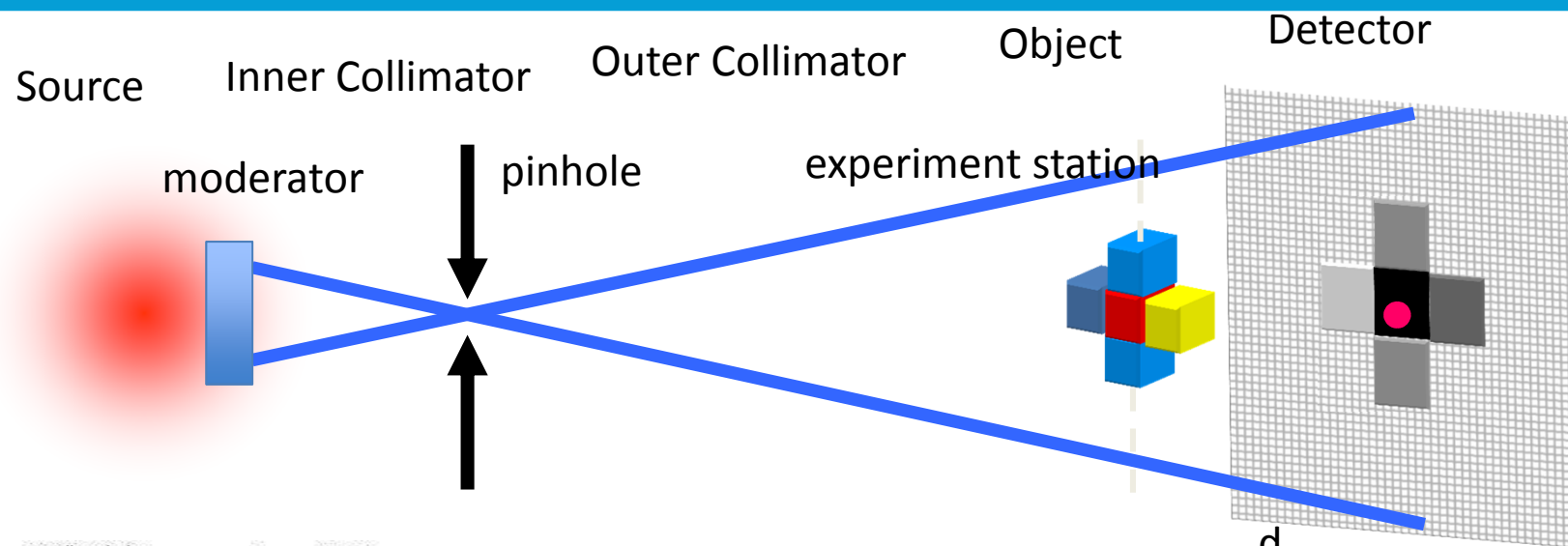
Direct
Tangential
Cold Moderator
Large
Small



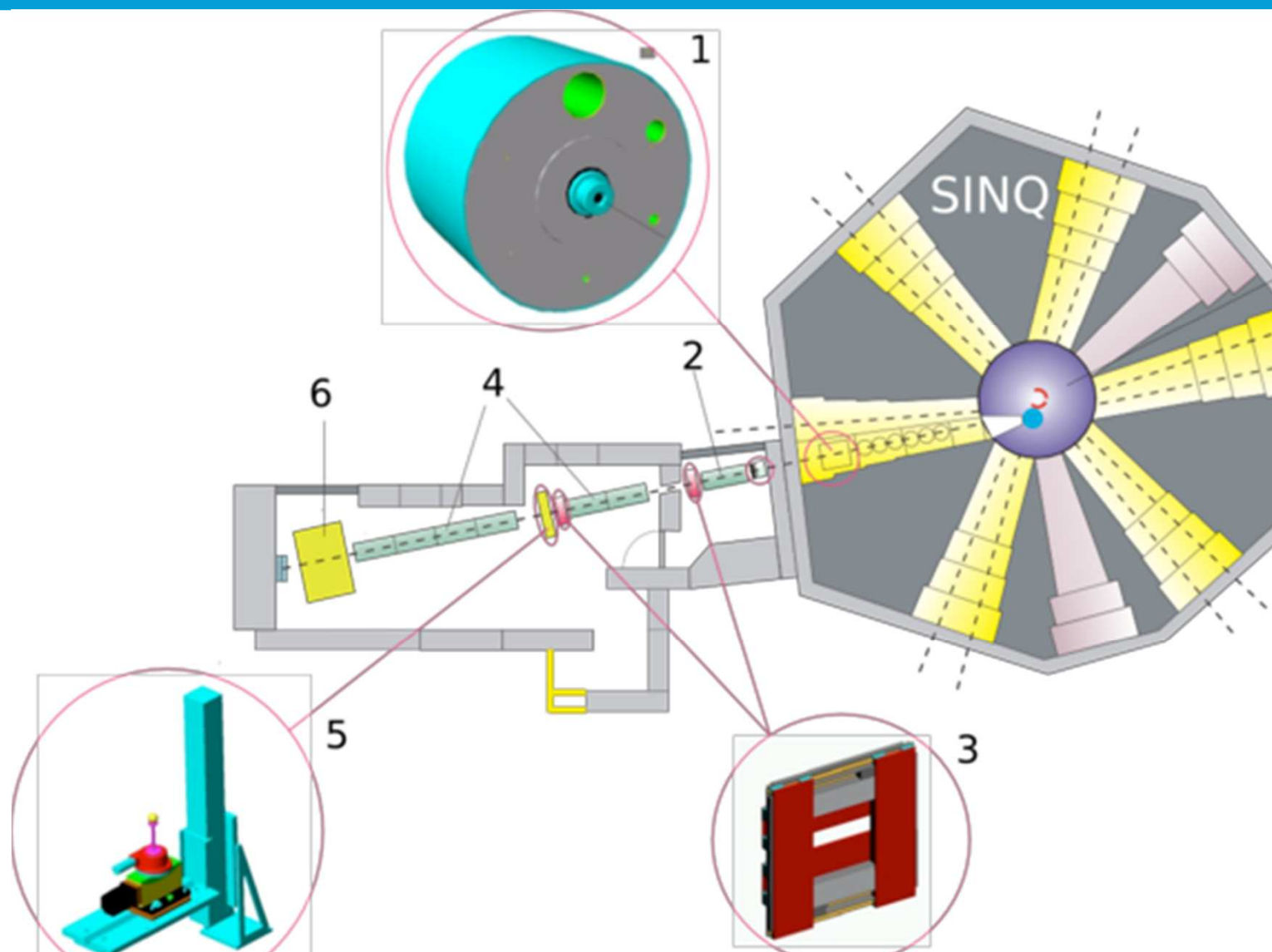
Beam Conditioning: Source to Detector



Beam Conditioning: Source to Detector



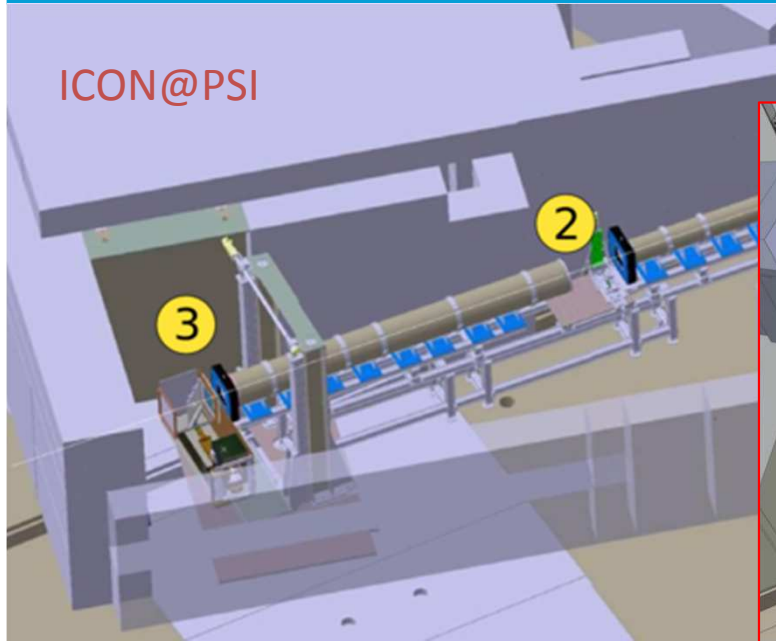
Beam Conditioning: Source to Detector



Standard Imaging Inst



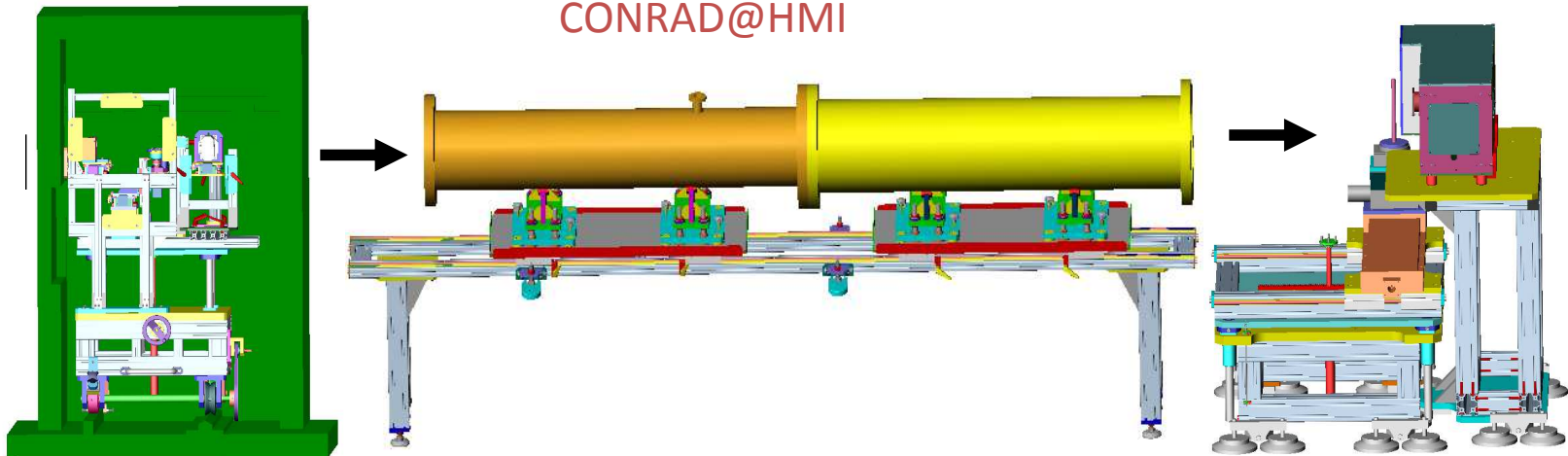
ICON@PSI



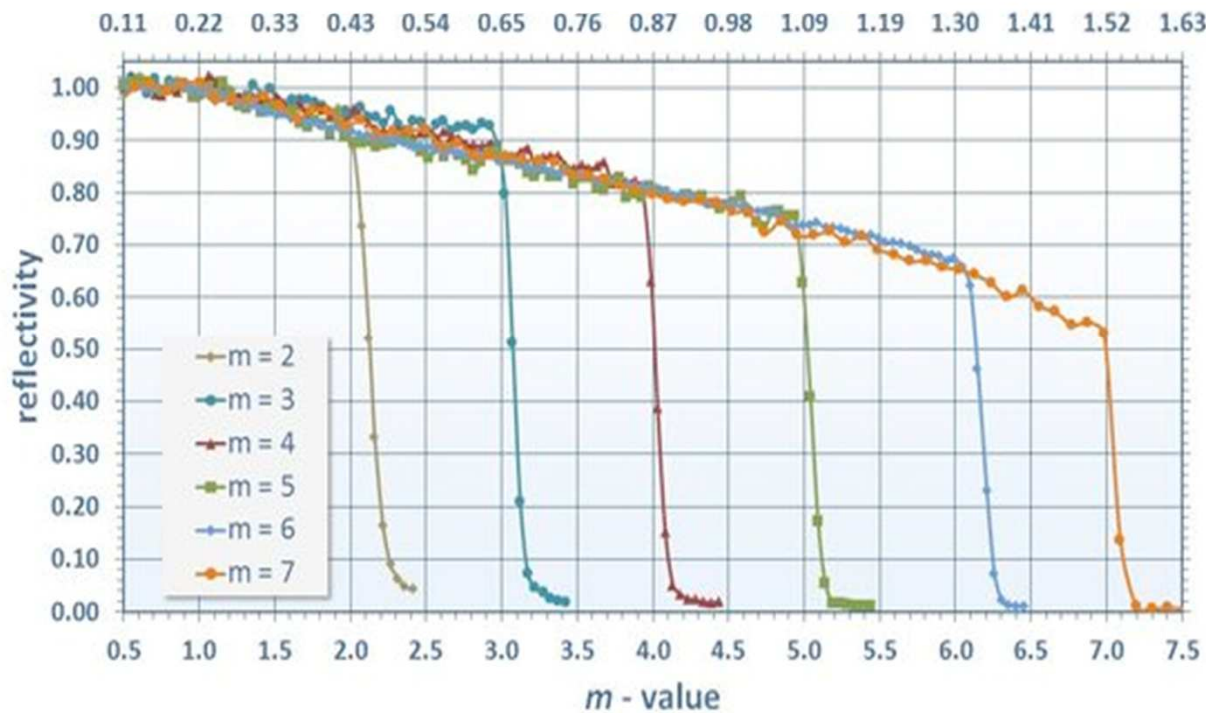
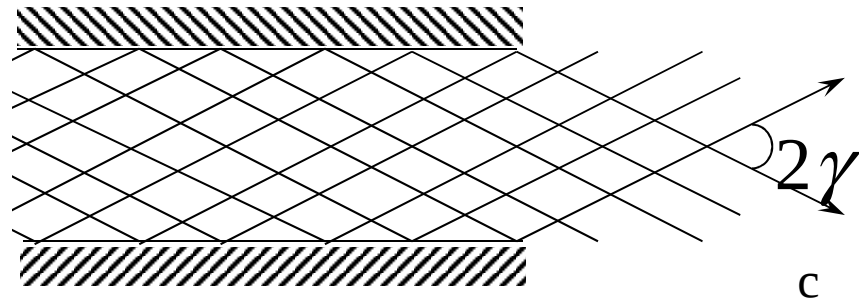
BOA@PSI



CONRAD@HMI



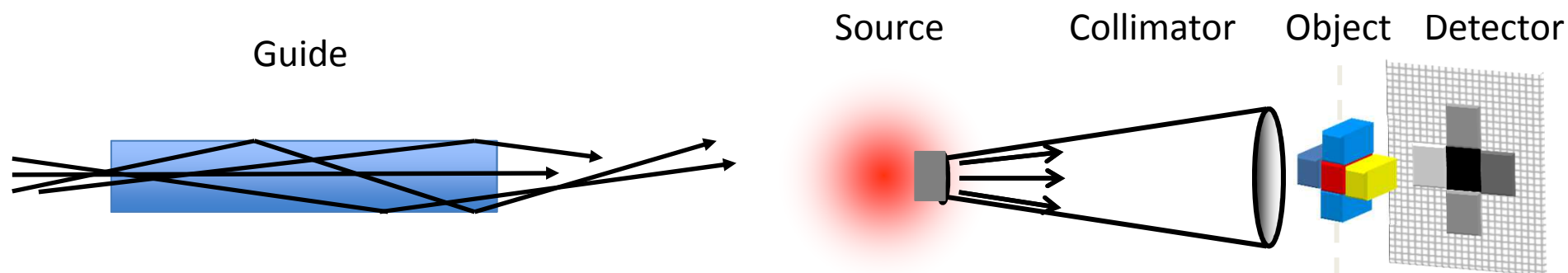
Standard Imaging Instrumentation



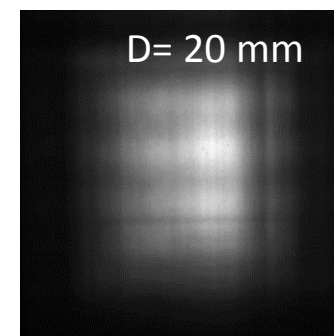
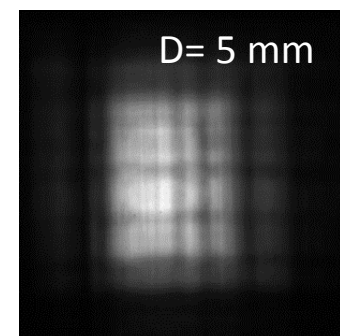
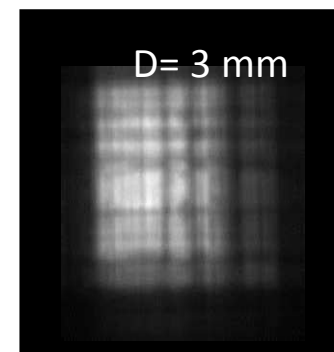
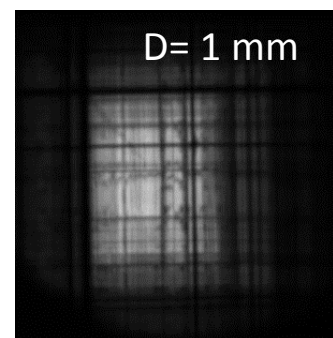
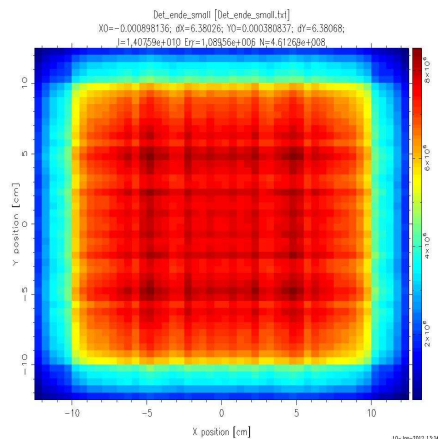
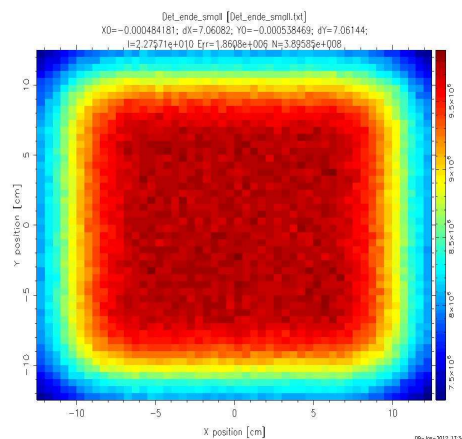
Lower limit L/D

$$L/D = 1/\tan(2\gamma_c(\lambda)).$$

Standard Imaging Instrumentation



Help: **DIFFUSER**



Standard Imaging Instrumentation

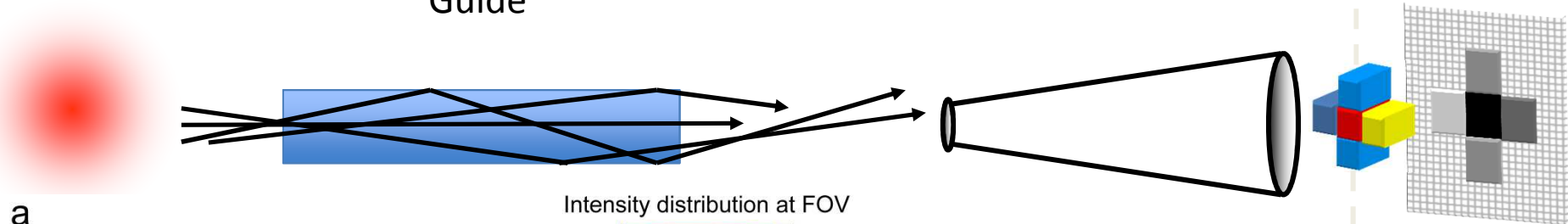
Source

Guide

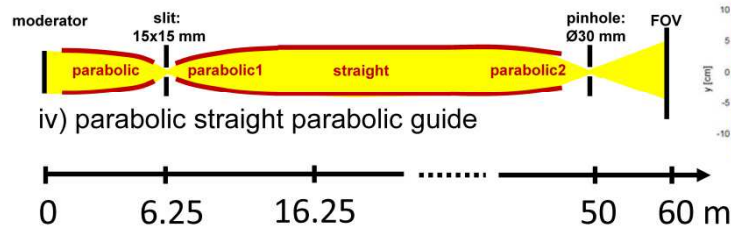
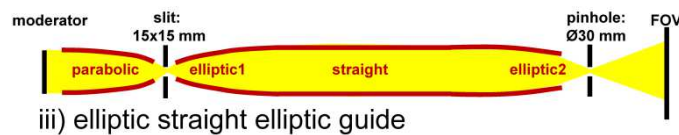
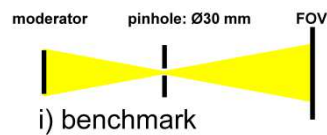
Collimator

Object

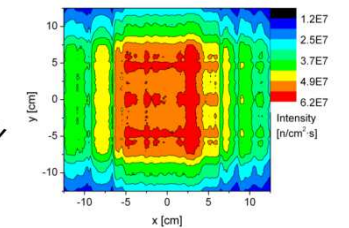
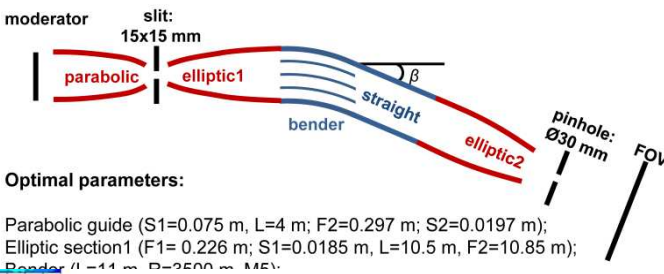
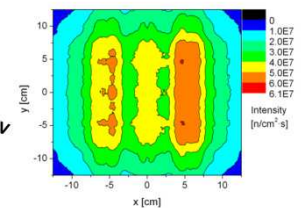
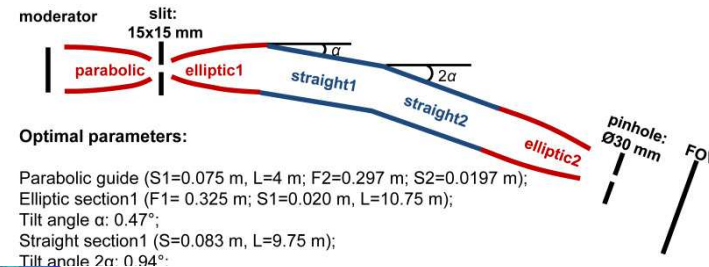
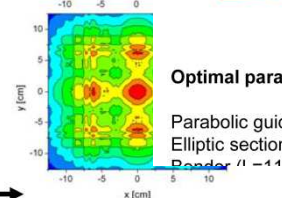
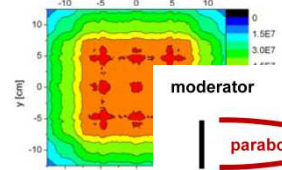
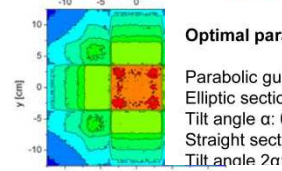
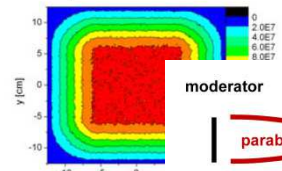
Detector



a

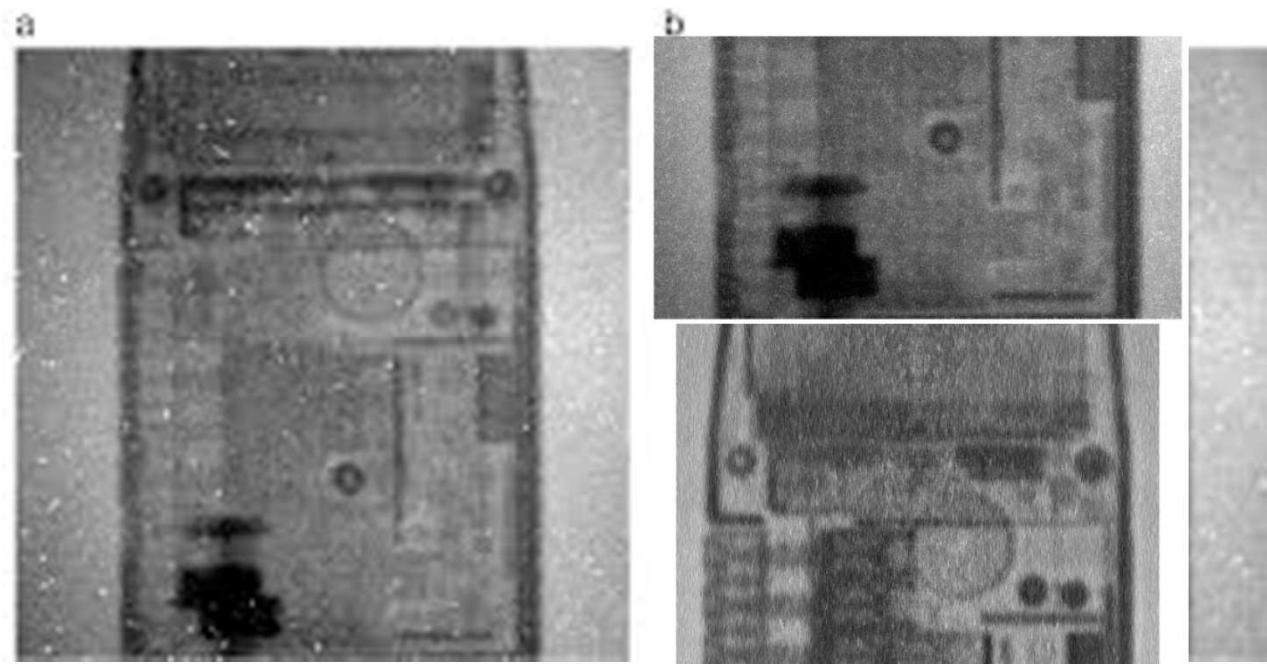


Intensity distribution at FOV



Standard Imaging Instrumentation

White spots



Standard Imaging Instrumentation

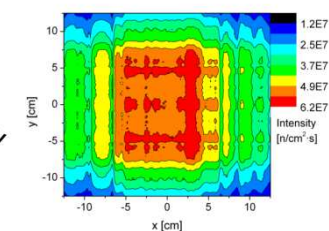
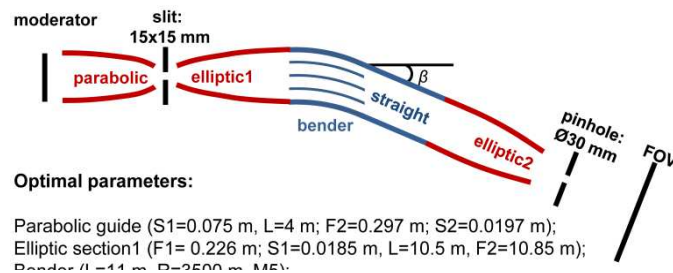
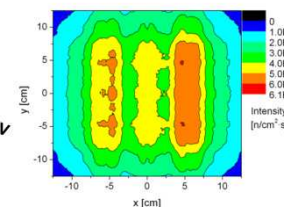
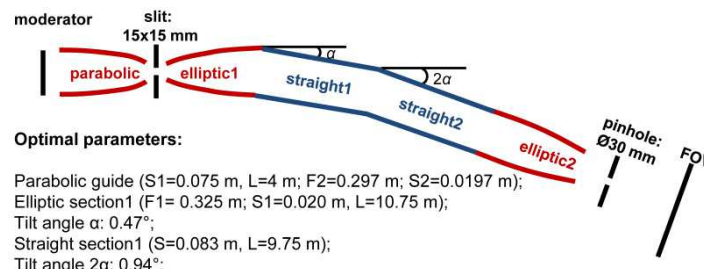
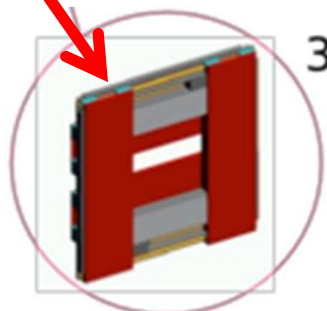
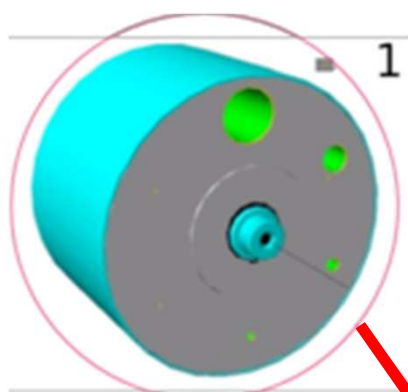
Source

Guide

Collimator

Object

Detector



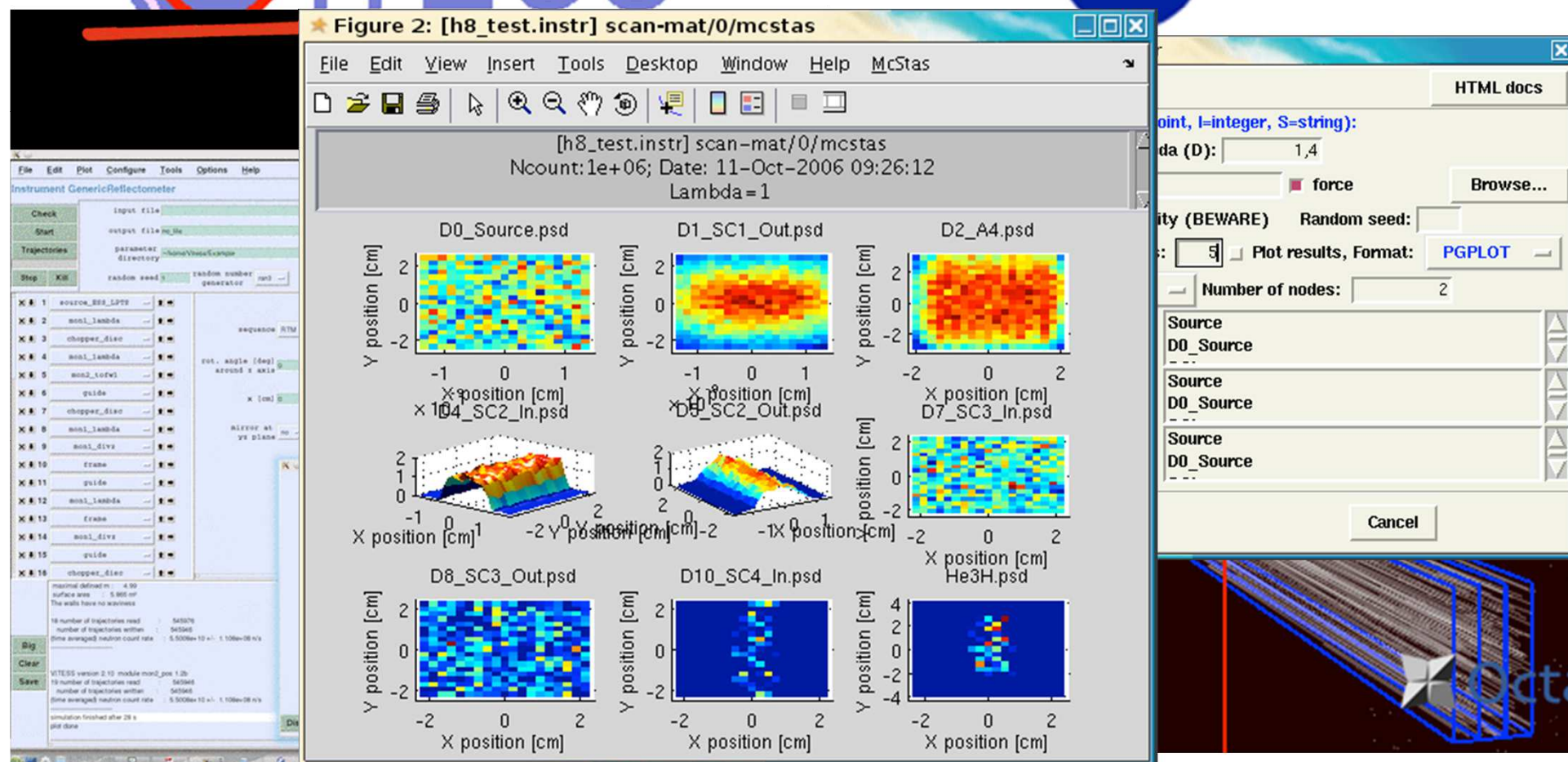
Standard Imaging Instrumentation



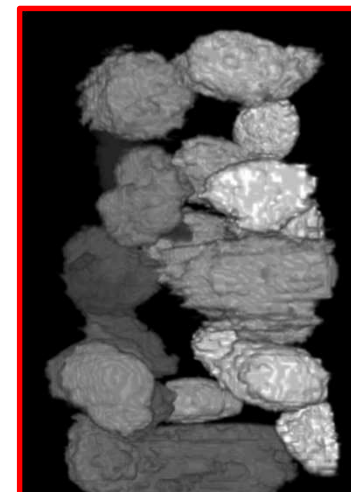
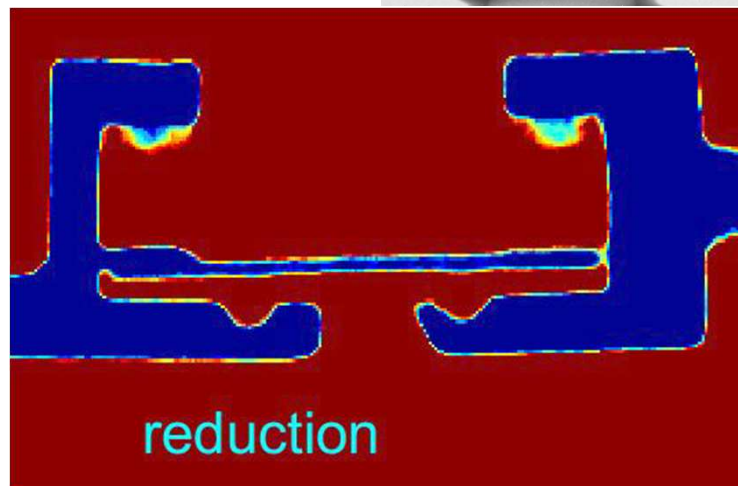
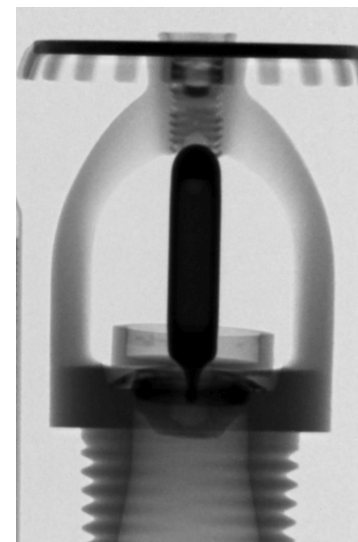
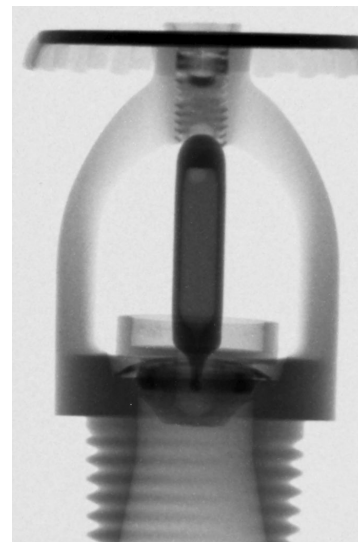
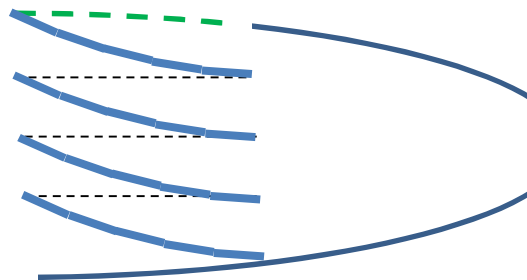
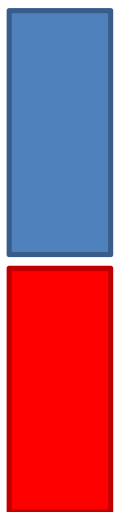
McStas



★ Figure 2: [h8_test.instr] scan-mat/0/mcstas



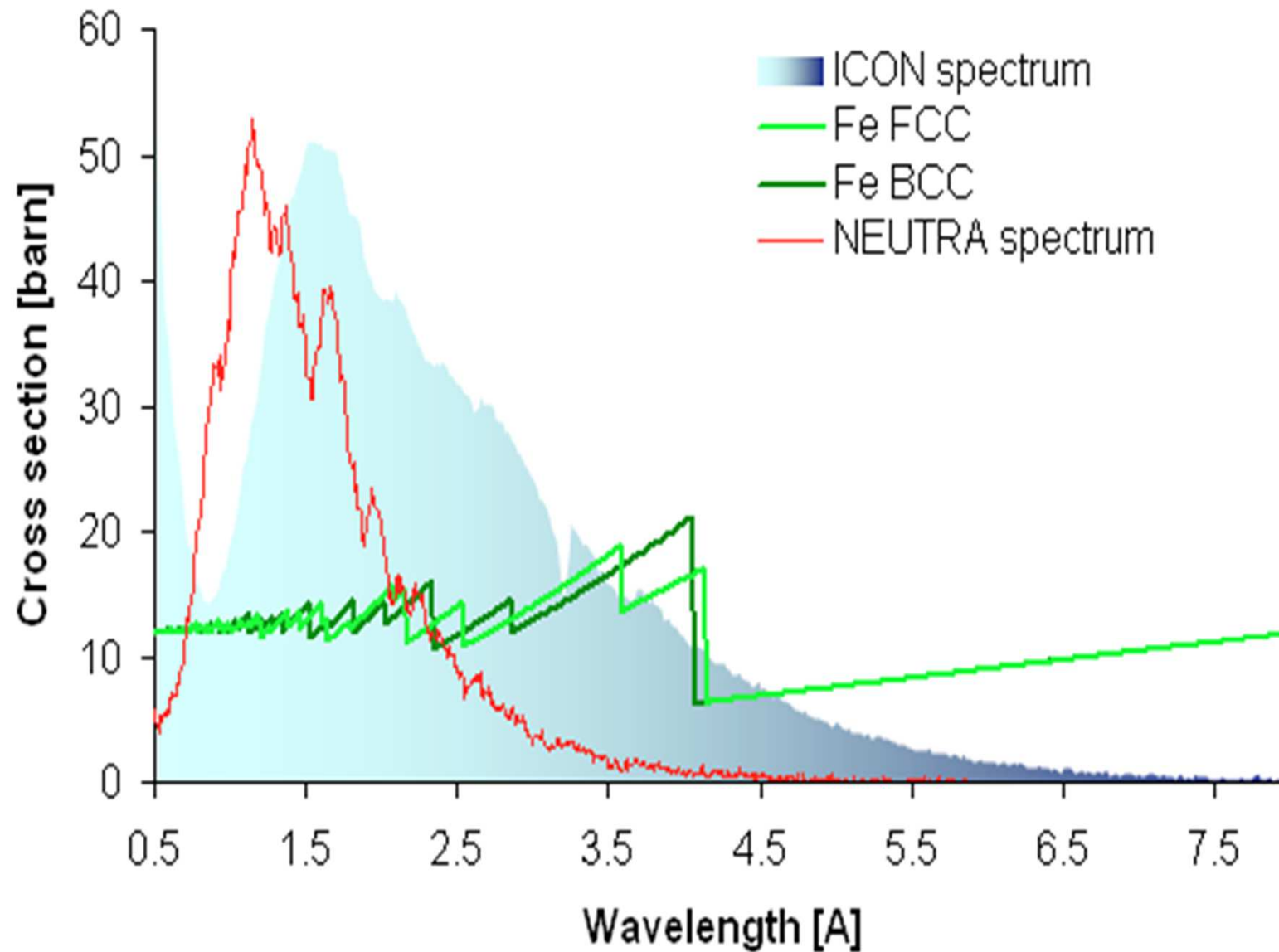
Complex solutions – based on simulations



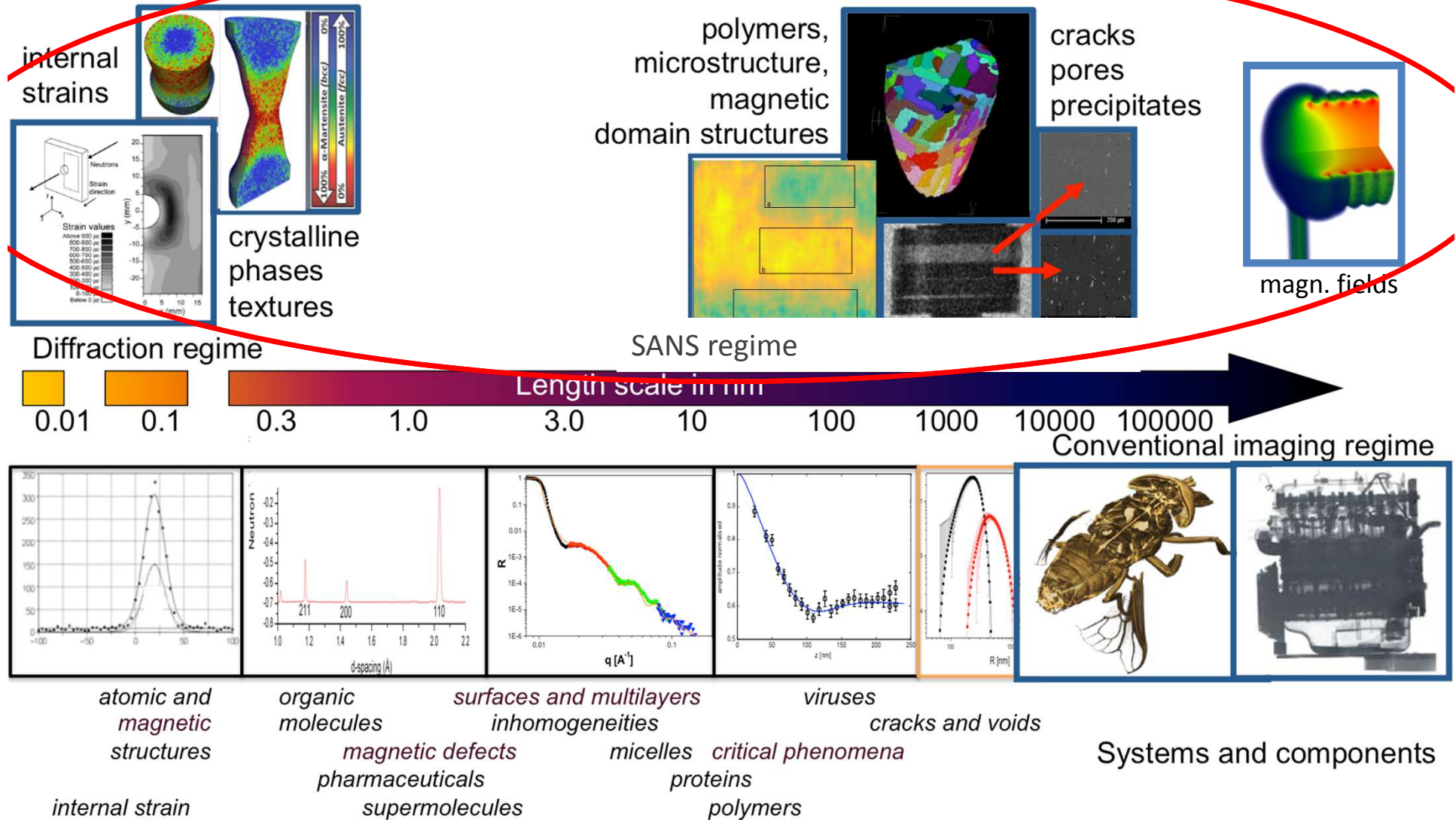
In-situ phase change

individual crystal grains

Complex solutions – based on simulations



Advanced Neutron Imaging



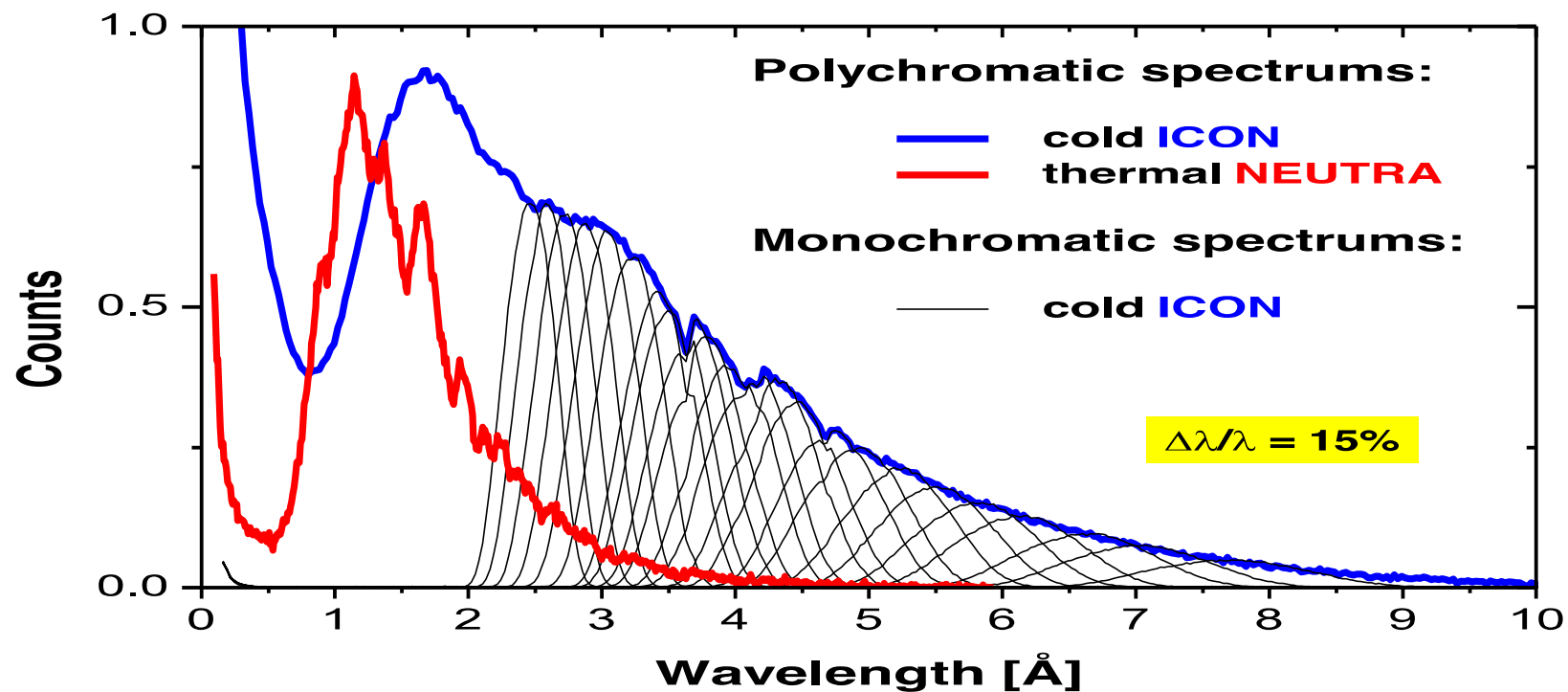
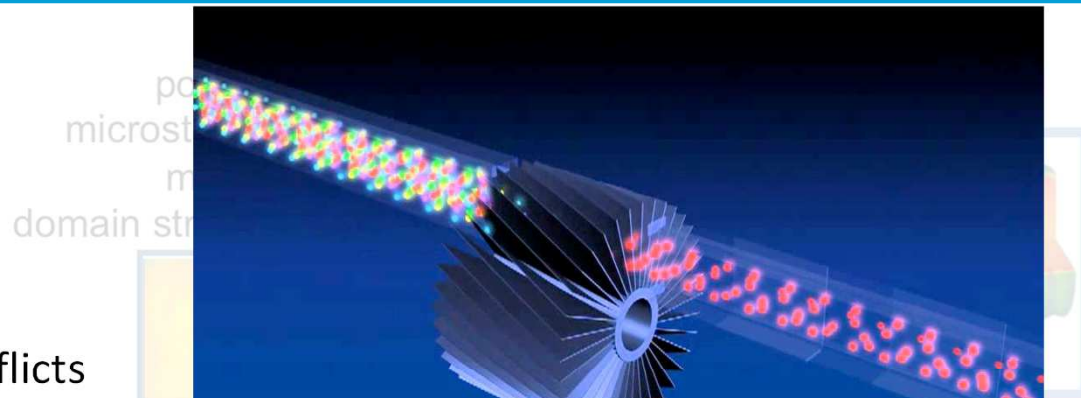
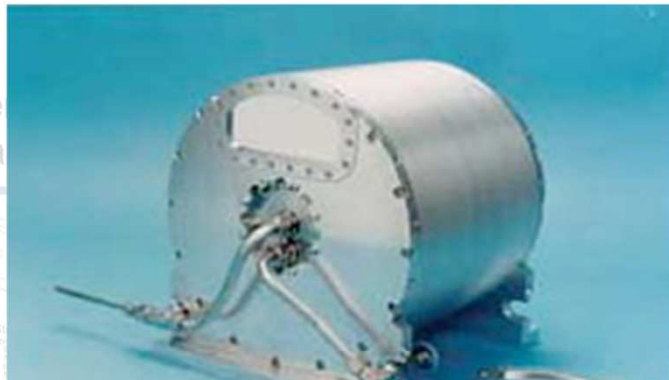
BASIC

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- Basic Imaging Requirements
- Beam Conditioning: Source to Detector
- Standard Imaging Instrumentation (continuous source)

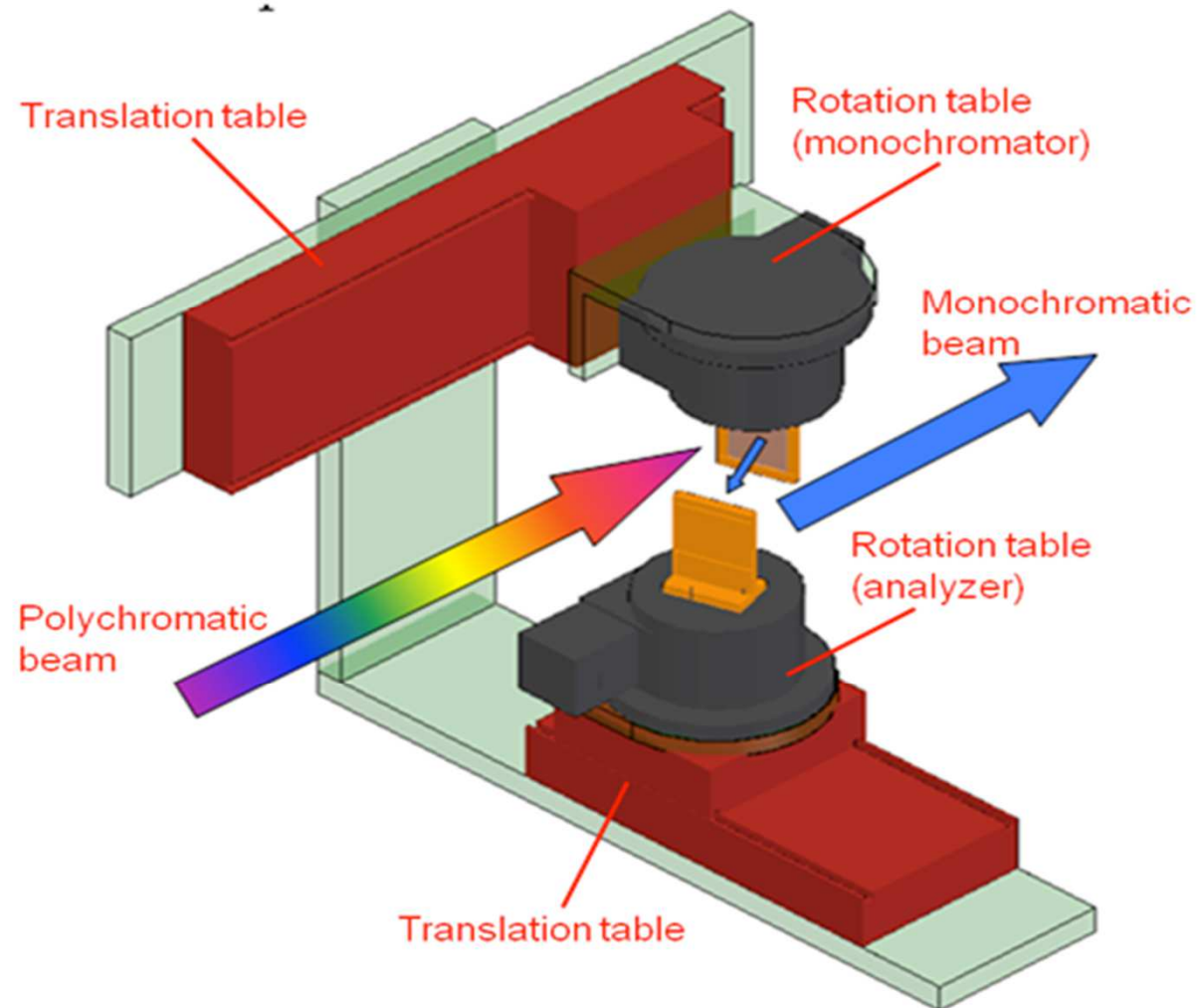
ADVANCED

- + Scattering, Diffraction and Polarized Neutrons
- + Additions to Basic Instrumentation: Wavelength Resolution
- + Instrumentation for a Time-of-flight Approach
- + Imaging Instrumentation at Pulsed Sources

Advanced – Wavelength Resolution



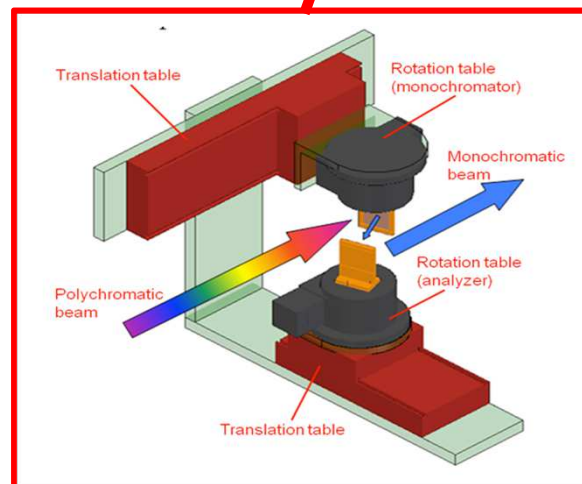
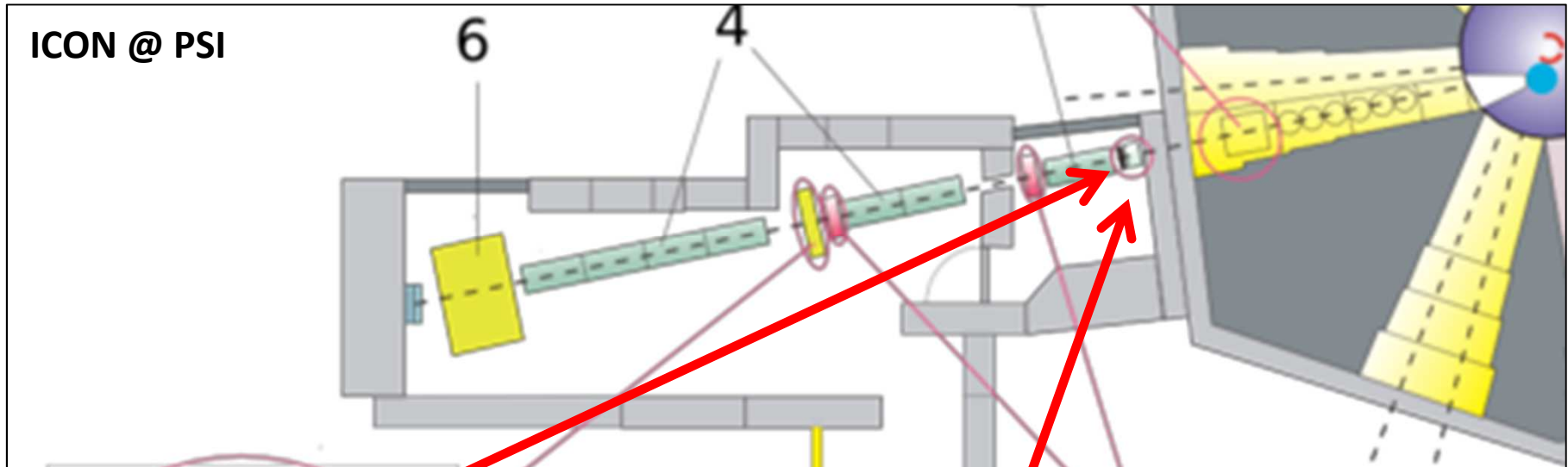
Advanced – Wavelength Resolution



Advanced Neutron Imaging – monochromators



ICON @ PSI

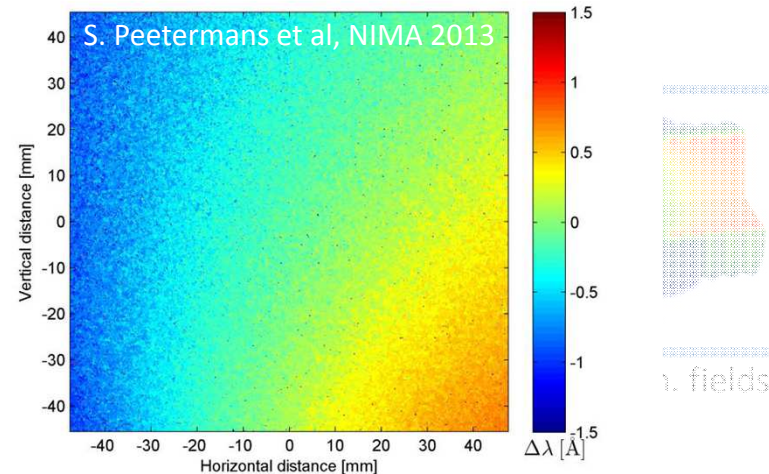


Advanced – Wavelength Resolution

Monochromators for Imaging:

- crystal monochromators
- velocity selectors
- choppers
- > homogeneity requirement conflicts

polymer
microstructure
magnetic
domain structure

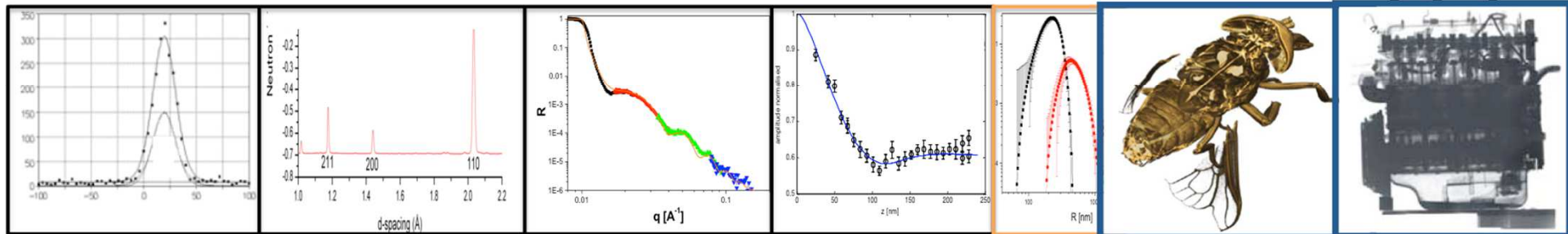


Diffraction regime

SANS regime

Length scale in nm

Conventional imaging regime



atomic and
magnetic
structures

organic
molecules

surfaces and multilayers
inhomogeneities

viruses

cracks and voids

Systems and components

magnetic defects
pharmaceuticals
supermolecules

micelles critical phenomena
proteins
polymers

internal strain

Advanced – Wavelength Resolution

Monochromators for Imaging:

- crystal monochromators
- velocity selectors
- **choppers**
- > homogeneity requirement conflicts

polymers,
microstructure,
magnetic
domain structures

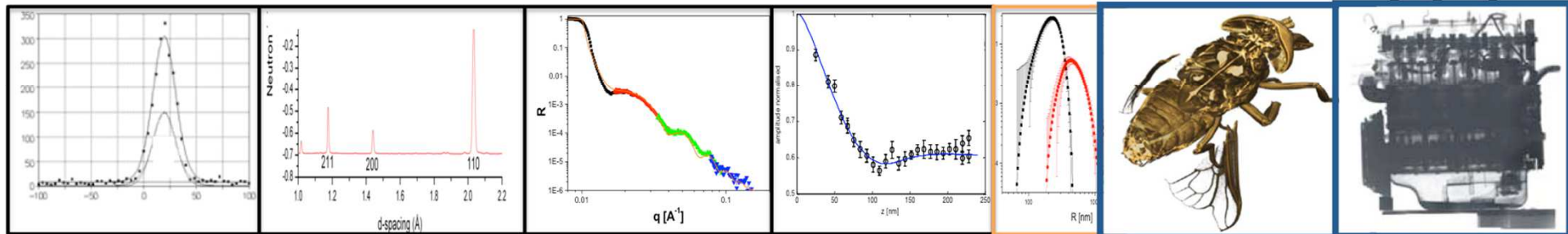
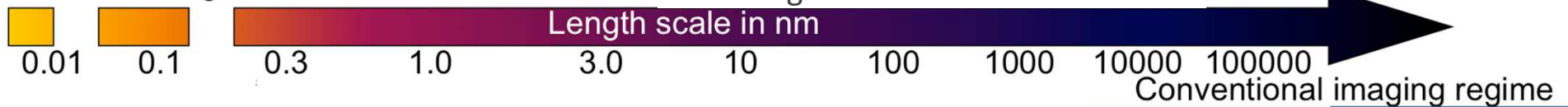
cracks
pores
precipitates

magn. fields

Diffraction regime

SANS regime

Length scale in nm



atomic and
magnetic
structures

organic
molecules

surfaces and multilayers
inhomogeneities

viruses

cracks and voids

Systems and components

magnetic defects
pharmaceuticals
supermolecules

micelles
critical phenomena
proteins
polymers

internal strain

Advanced – Wavelength Resolution ToF vs Monochromatic



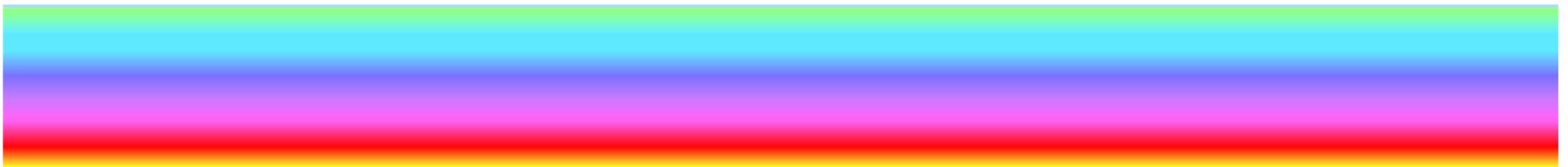
Monochromator



Velocity selector

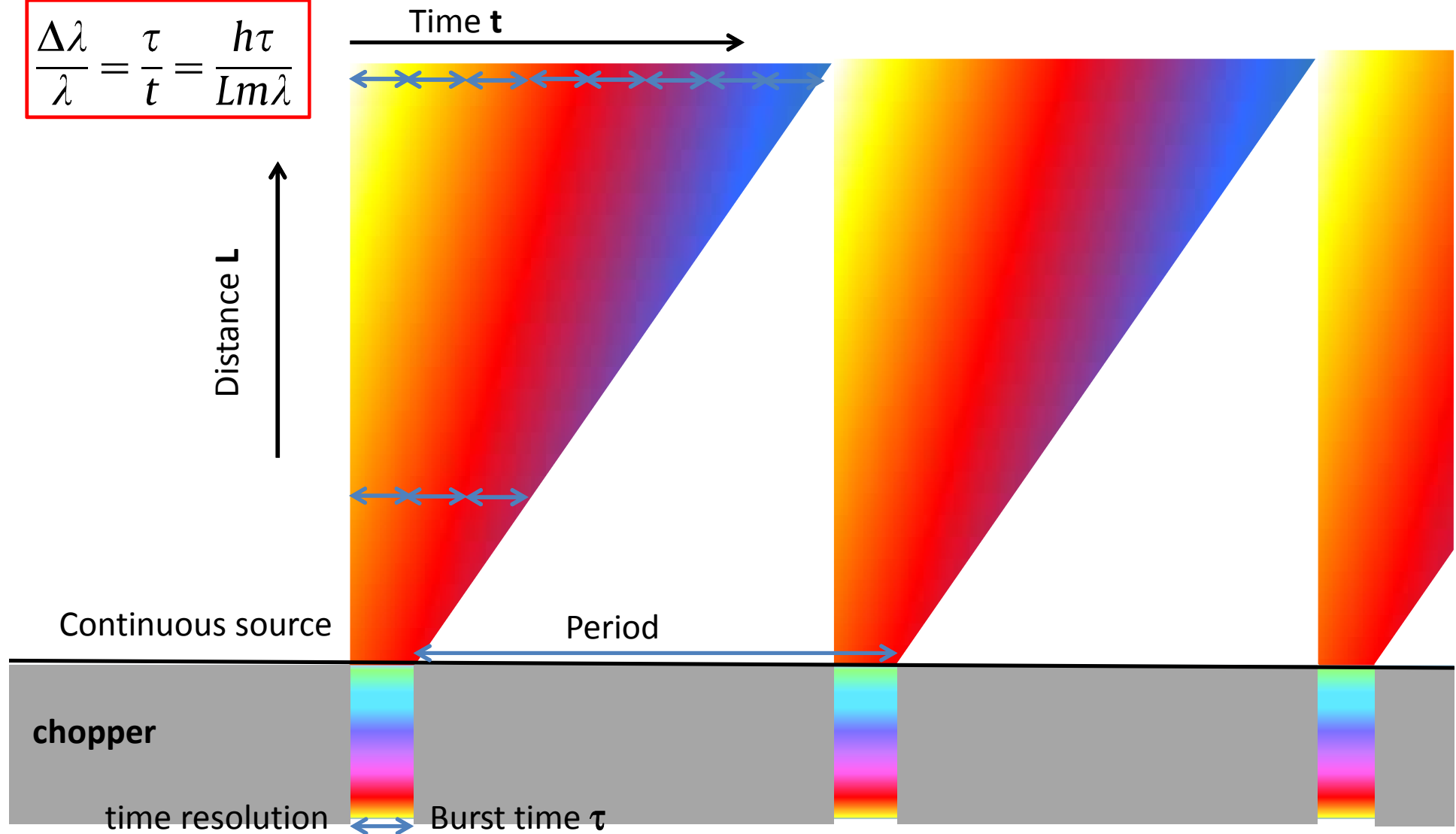


Continuous source

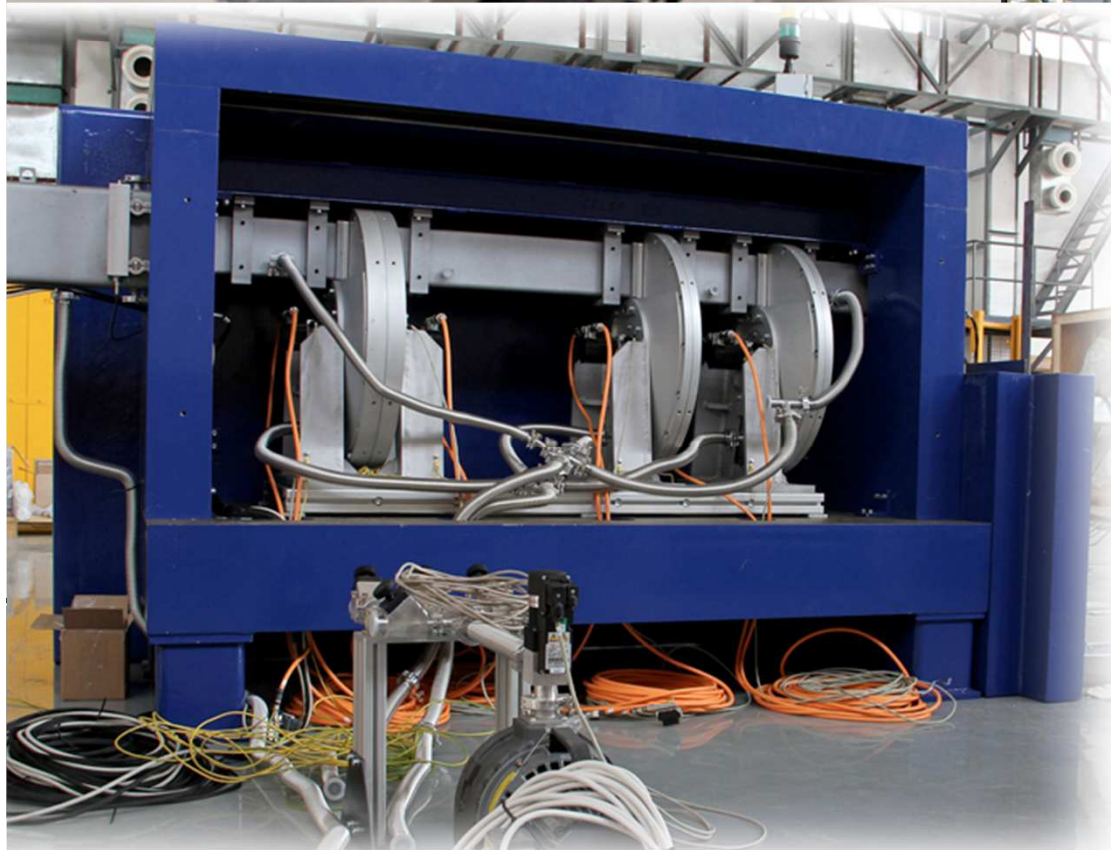
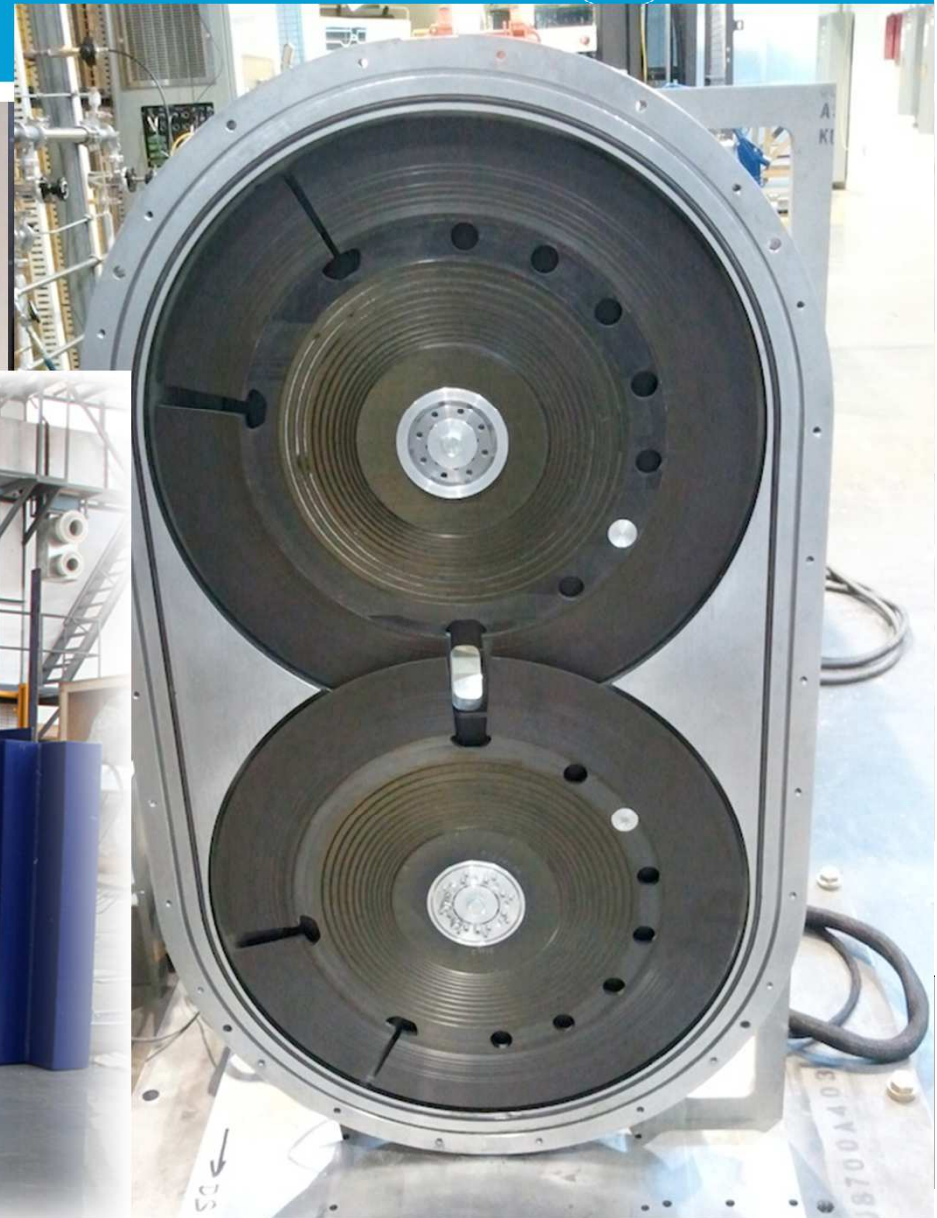


Advanced – Wavelength Resolution ToF vs Monochromatic

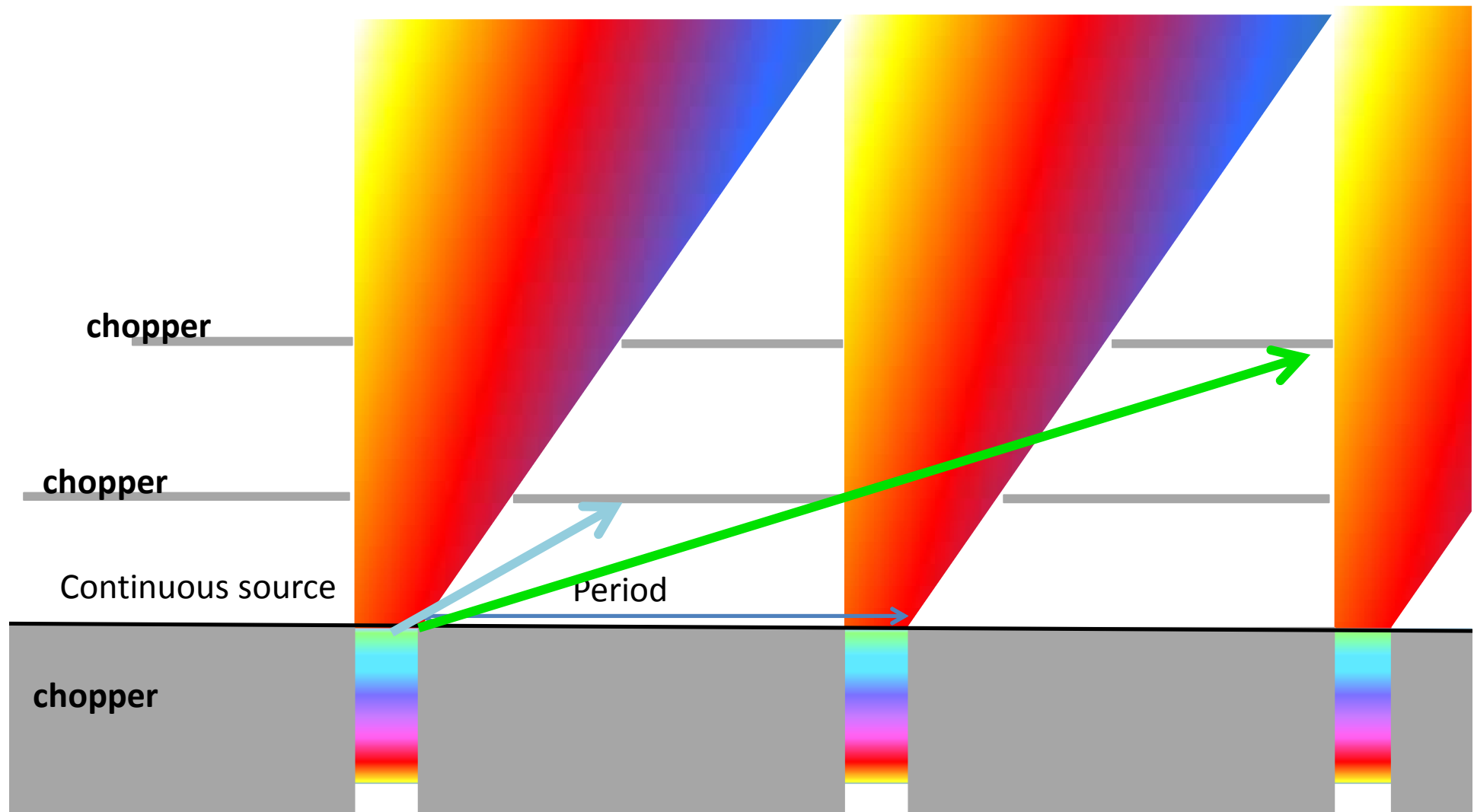
$$\frac{\Delta\lambda}{\lambda} = \frac{\tau}{t} = \frac{h\tau}{Lm\lambda}$$



Advanced – Wavelength Resolution ToF vs Monochromatic



Advanced – Wavelength Resolution ToF vs Monochromatic



Advanced – Wavelength Resolution ToF vs Monochromatic



Monochromator
Pulsed source



Continuous source with chopper



Advanced – Wavelength Resolution ToF vs Monochromatic



Pulsed source



Continuous source with velocity selector



Advanced – Wavelength Resolution ToF vs Monochromatic



Pulsed source



Continuous source with chopper

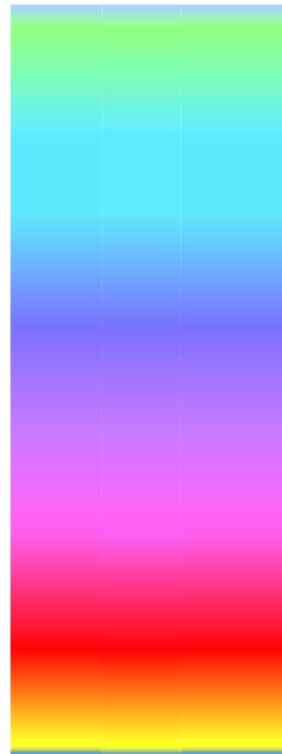


Advanced – Wavelength Resolution ToF vs Monochromatic



Pulsed source

ESS



ESS
with chopper



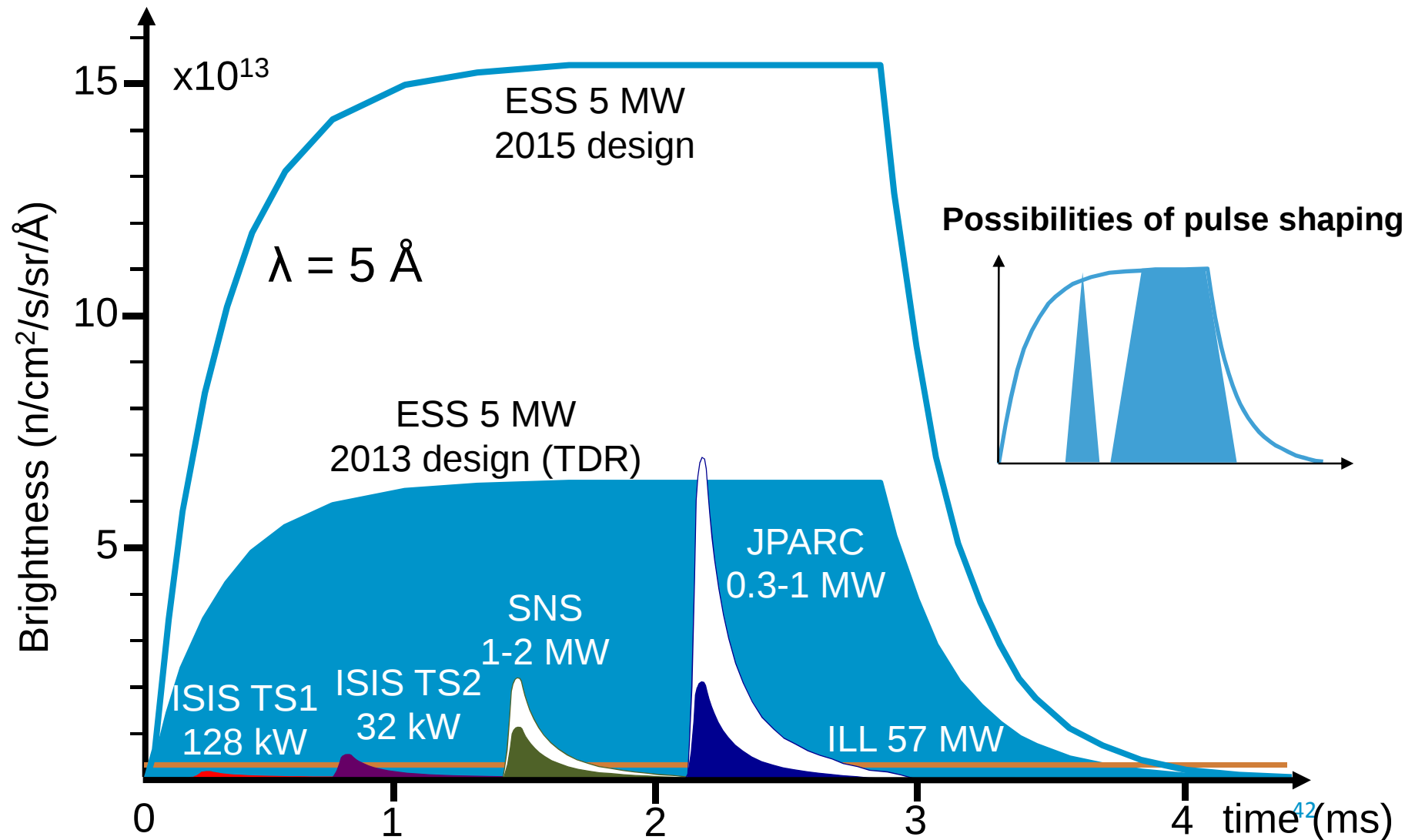
ESS
with chopper



Continuous source with chopper



Advanced – Wavelength Resolution ToF vs Monochromatic



Advanced – Wavelength Resolution

Pulsed - only efficient when wavelength range probed

ToF vs Monochromatic



Monochromator

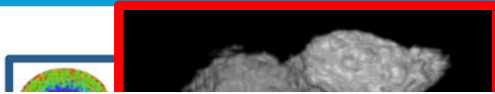
ToF monochromatic



Advanced – Wavelength Resolution

Pulsed - only efficient when wavelength range probed

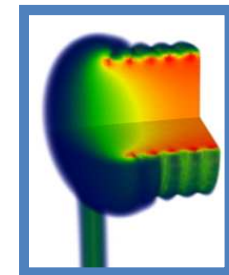
ToF vs Monochromatic



$$\frac{V_s(\xi_{GI})}{V_0(\xi_{GI})} = \int_{-\infty}^{\infty} dq S(q) \cos(\xi_{GI}q) = G(\xi_{GI})$$

$$\xi_{GI} = \frac{\lambda L_s}{p}$$

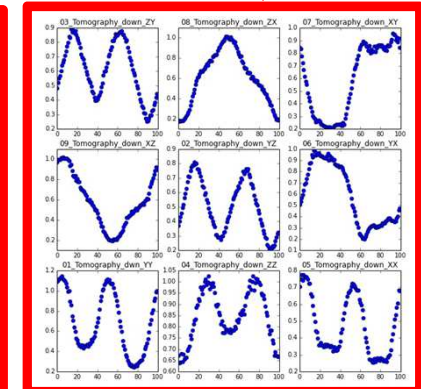
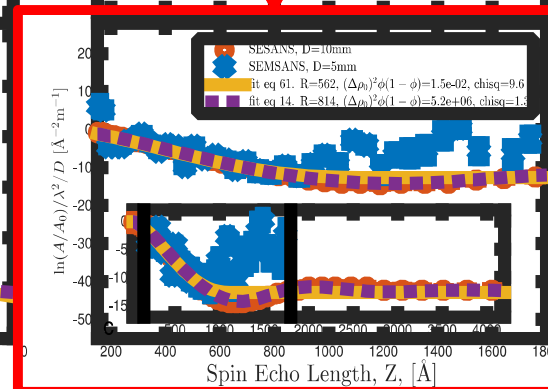
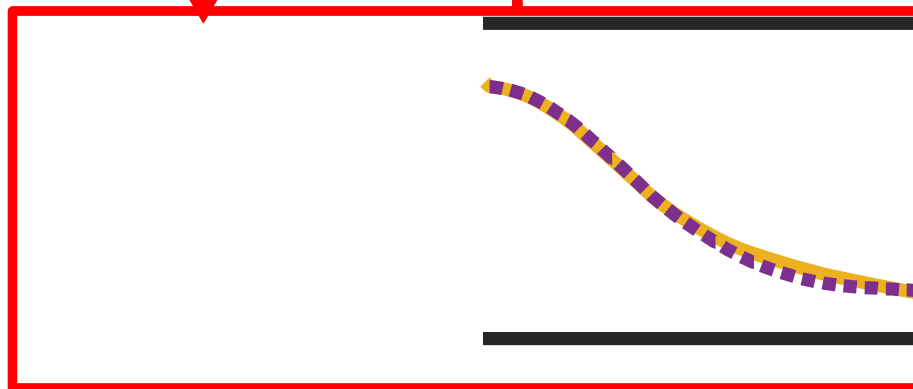
M. Strobl, Scientific Rep. 2014



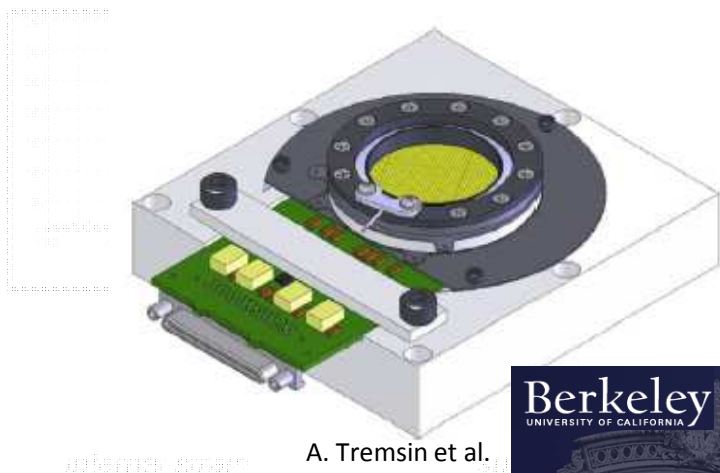
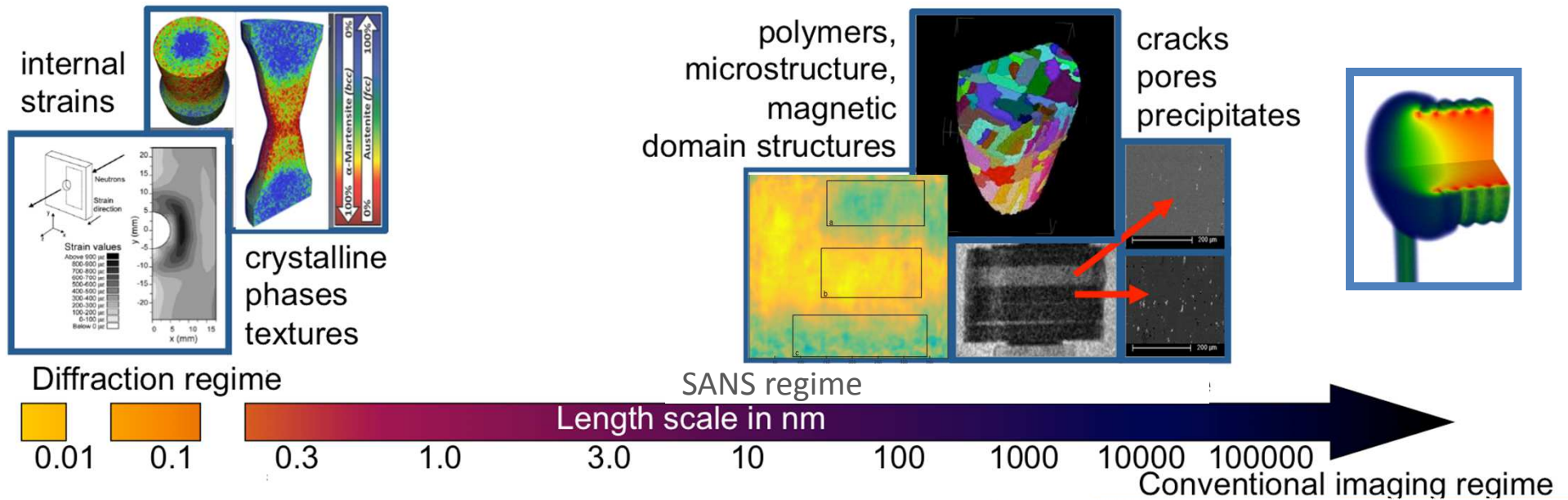
magn. fields

SANS regime

00000
ventional imaging regime



Advanced – Wavelength Resolution ToF vs Monochromatic

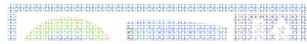


pulsed neutron imaging

- High flux
 - Large size
 - High spatial resolution
 - High time resolution
- detector requirement conflicts

Advanced Neutron Imaging Instrumentation

Pulsed - only efficient when wavelength range probed



0,3%
wavelength resolution

1%

10%



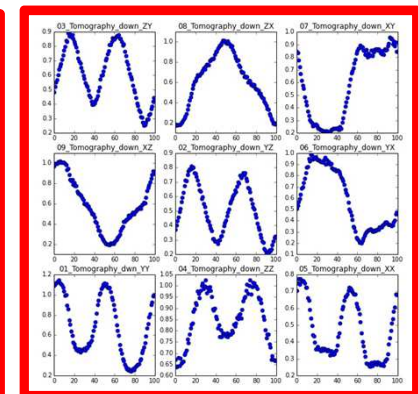
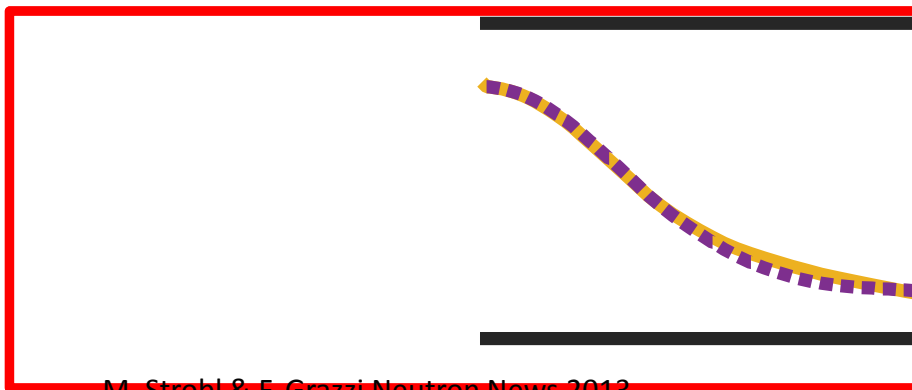
polymers



polymers

polymers

00000
ventional imaging regime



Advanced Neutron Imaging Instrumentation

Pulsed - only efficient when wavelength range probed



0,3%

wavelength resolution

1%

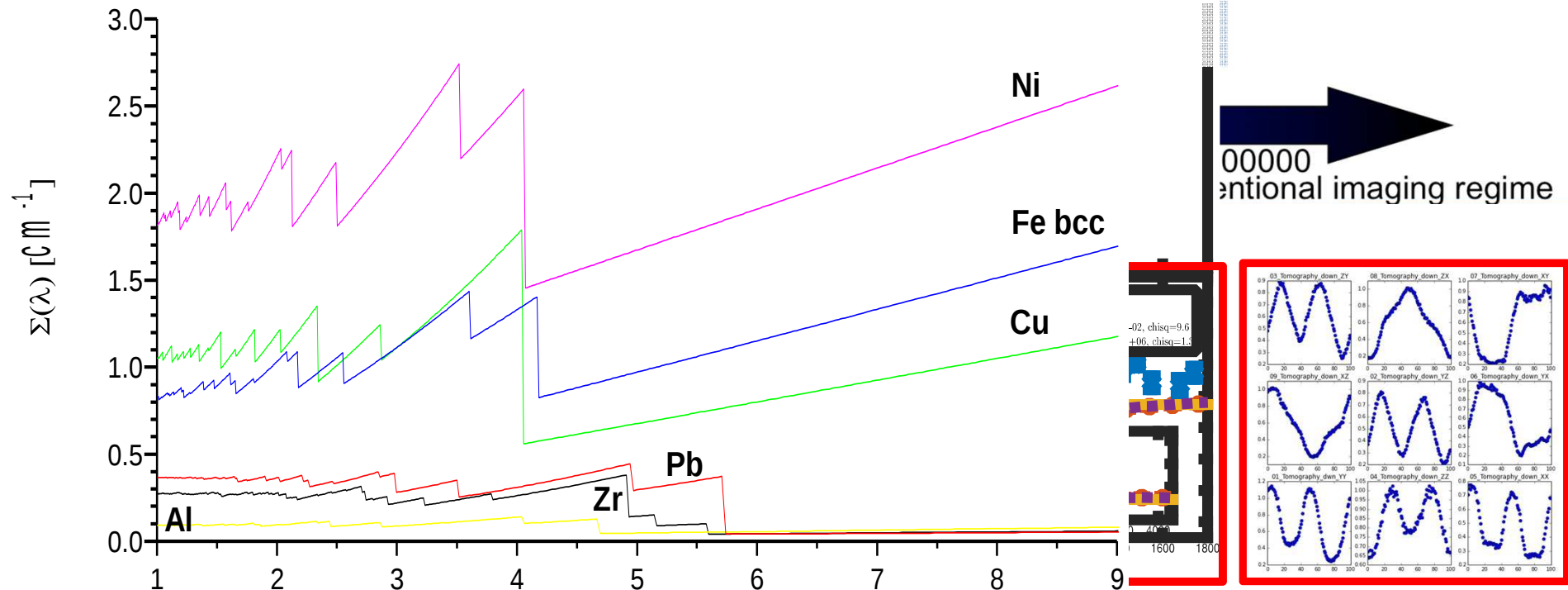
wavelength bandwidth

10%

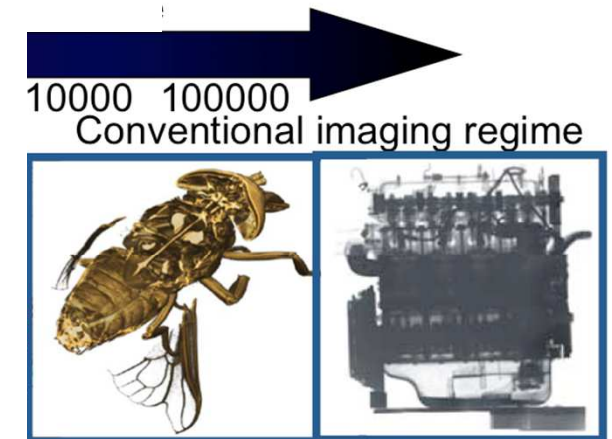
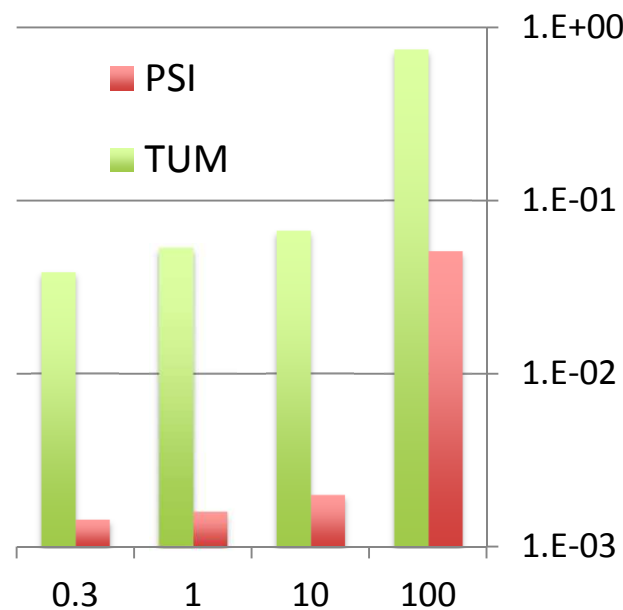
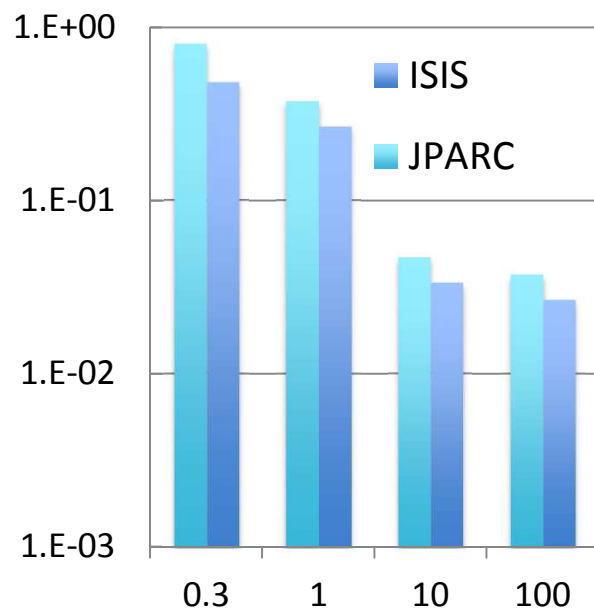
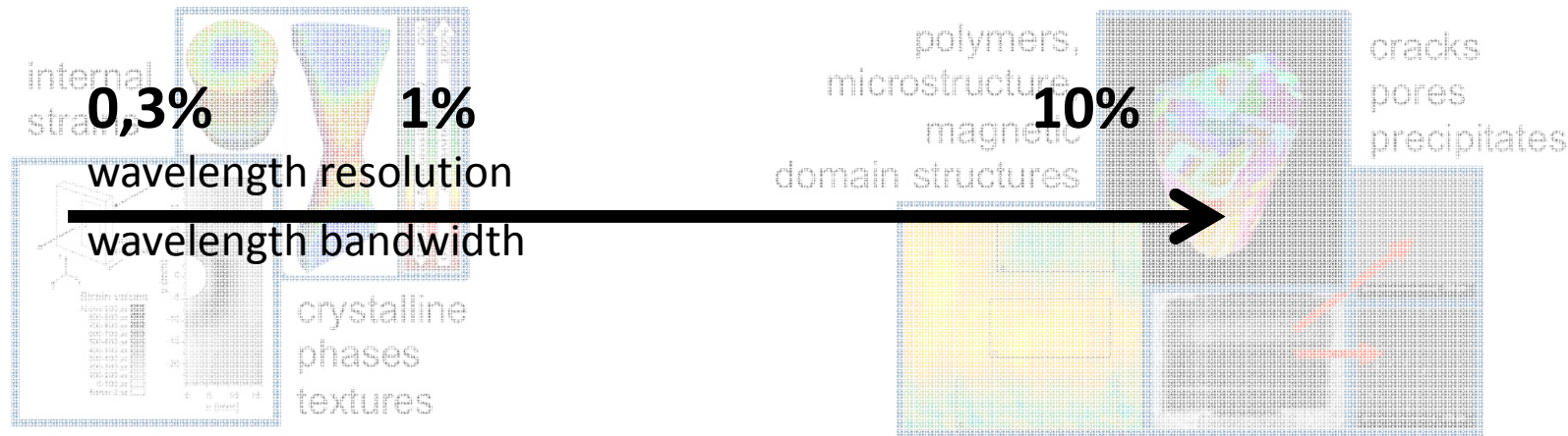


rates

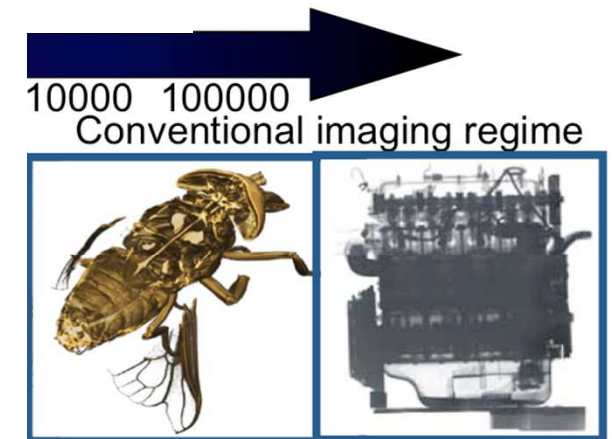
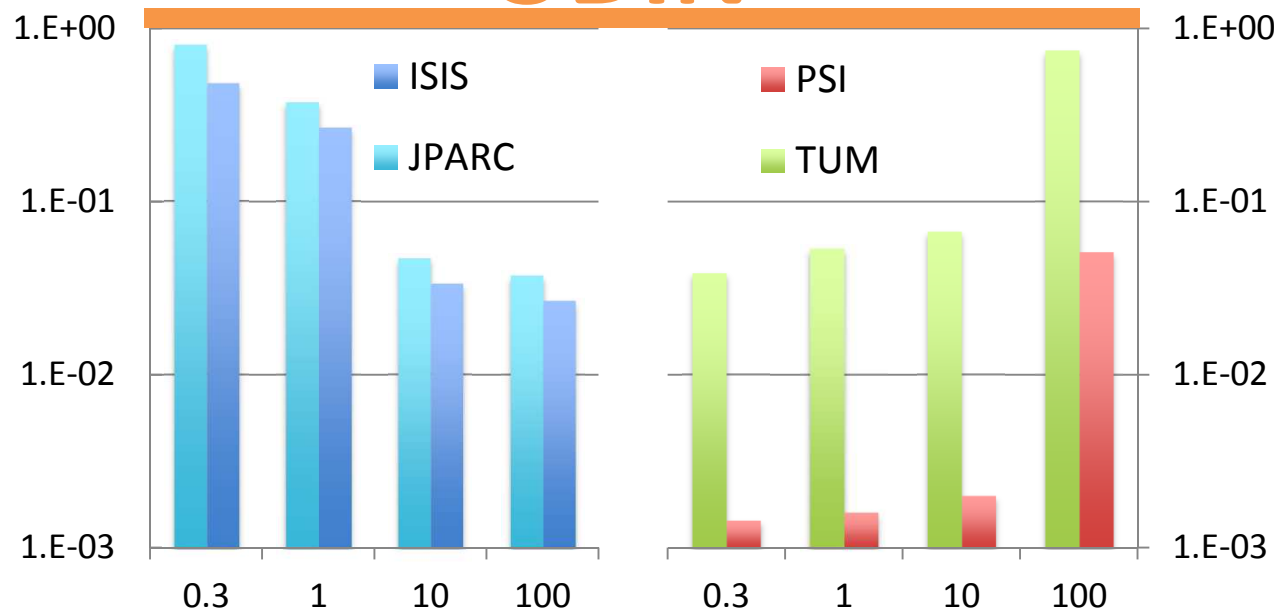
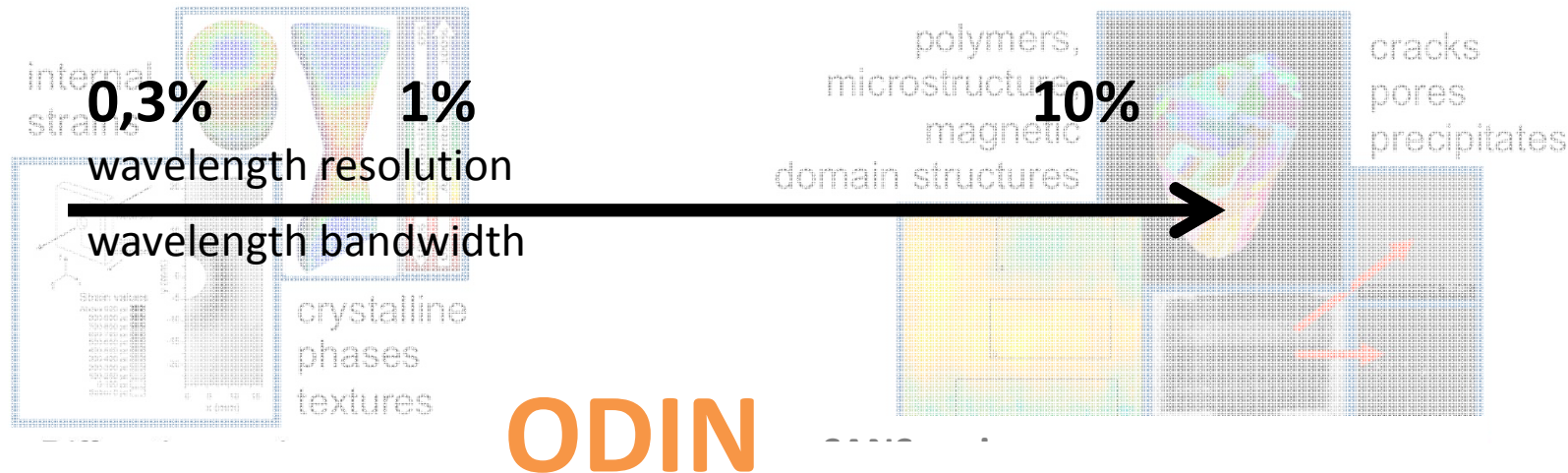
00000
ventional imaging regime



Advanced Neutron Imaging Instrumentation



Advanced Neutron Imaging – ODIN @ ESS



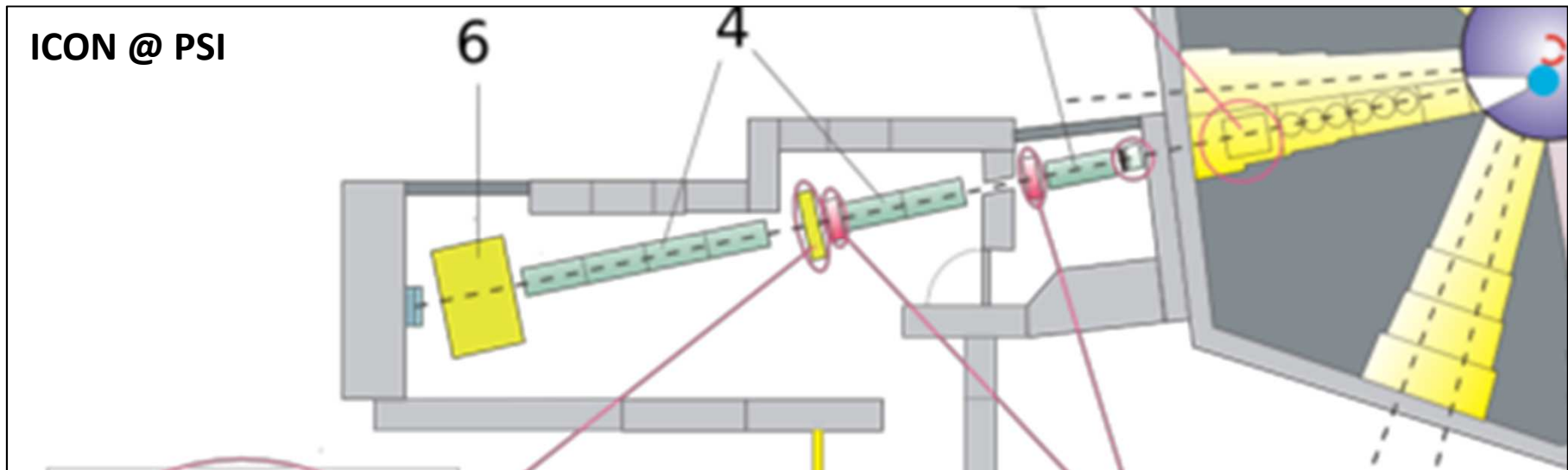
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Systems and components

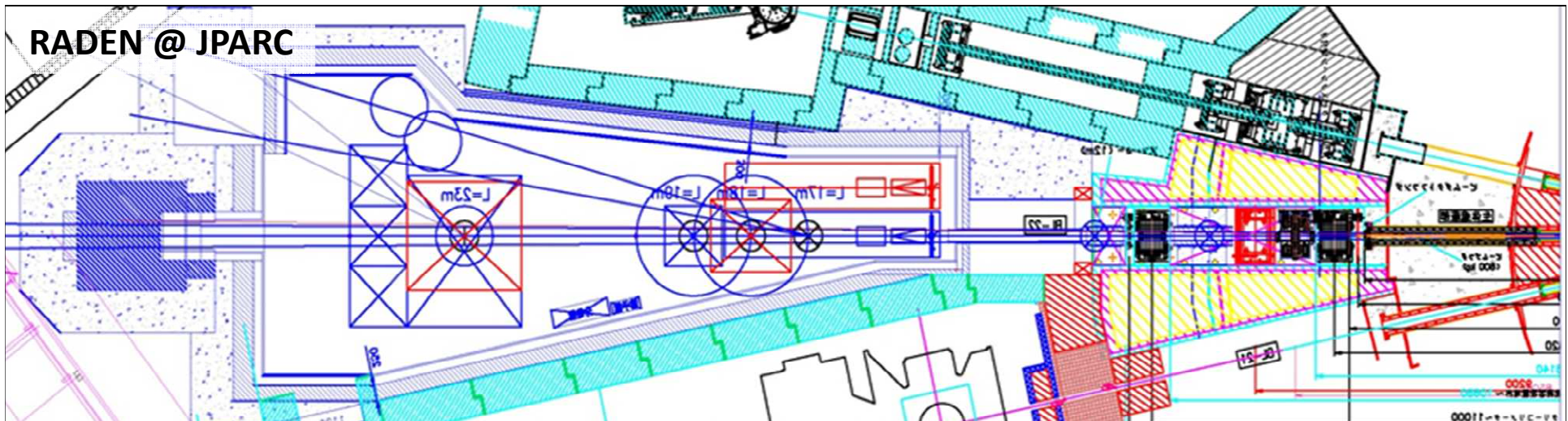
Advanced Neutron Imaging – SP sources



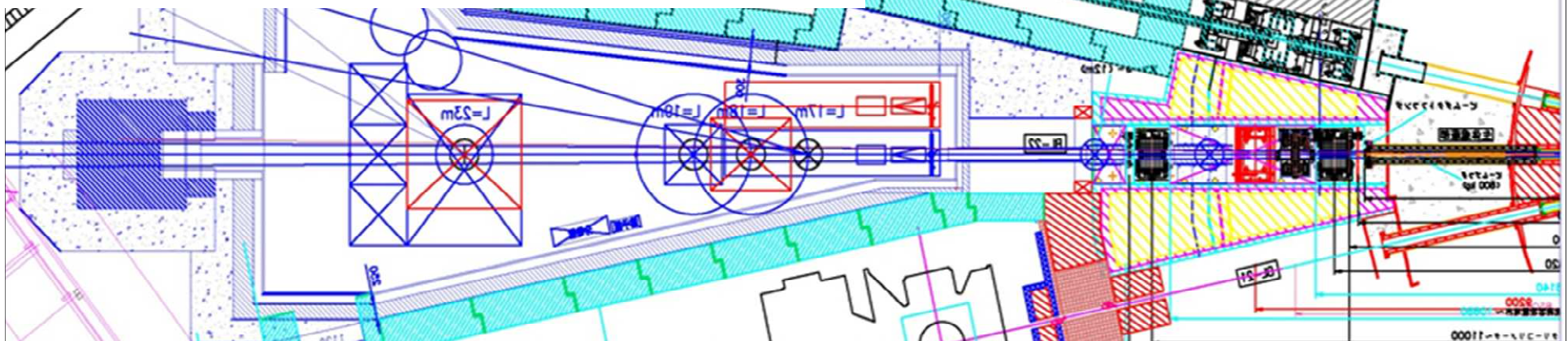
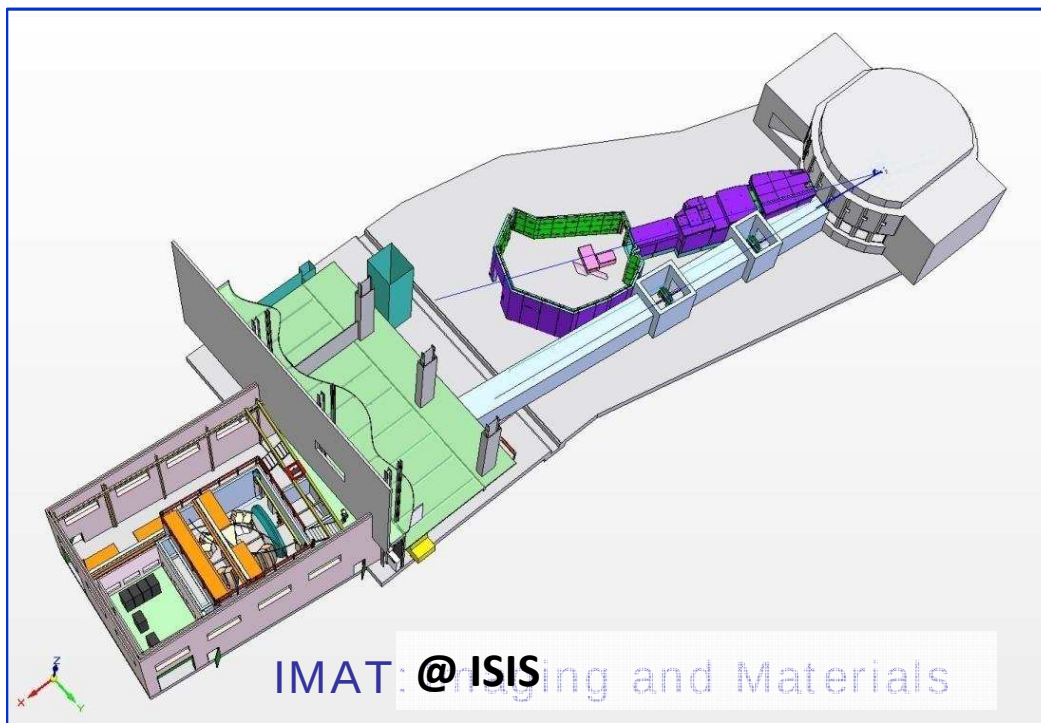
ICON @ PSI



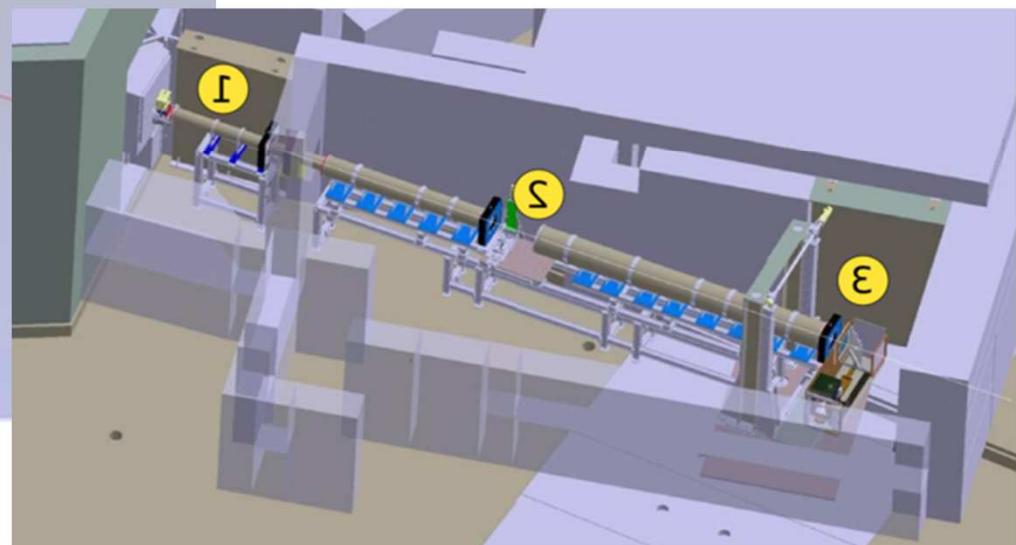
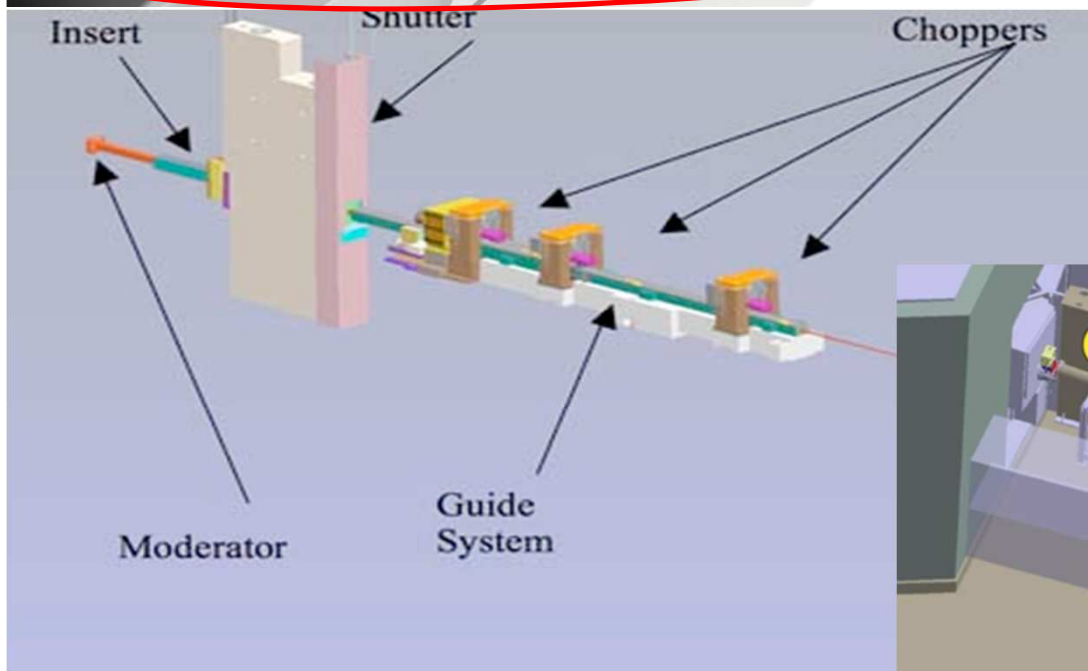
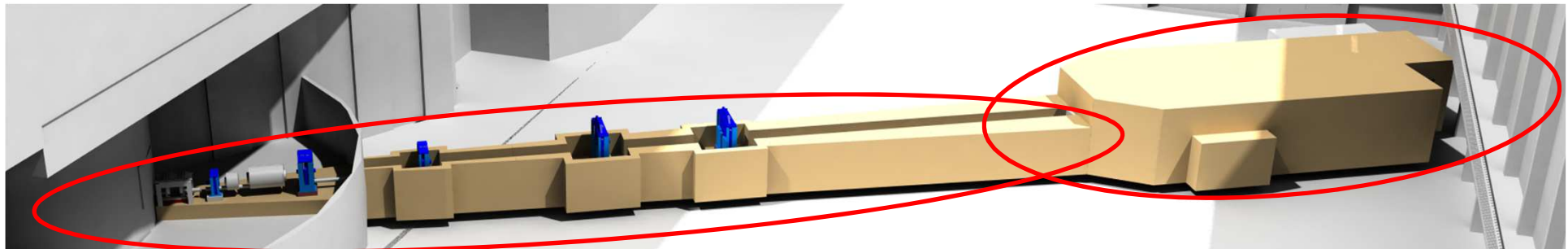
RADEN @ JPARC



Advanced Neutron Imaging – SP sources

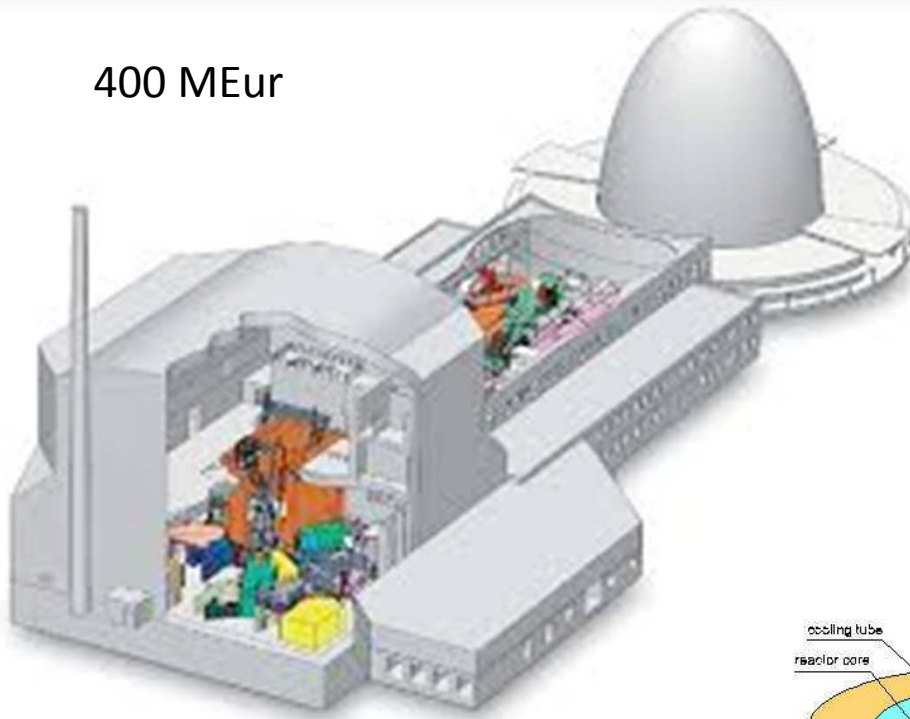


Advanced Neutron Imaging – ODIN @ ESS

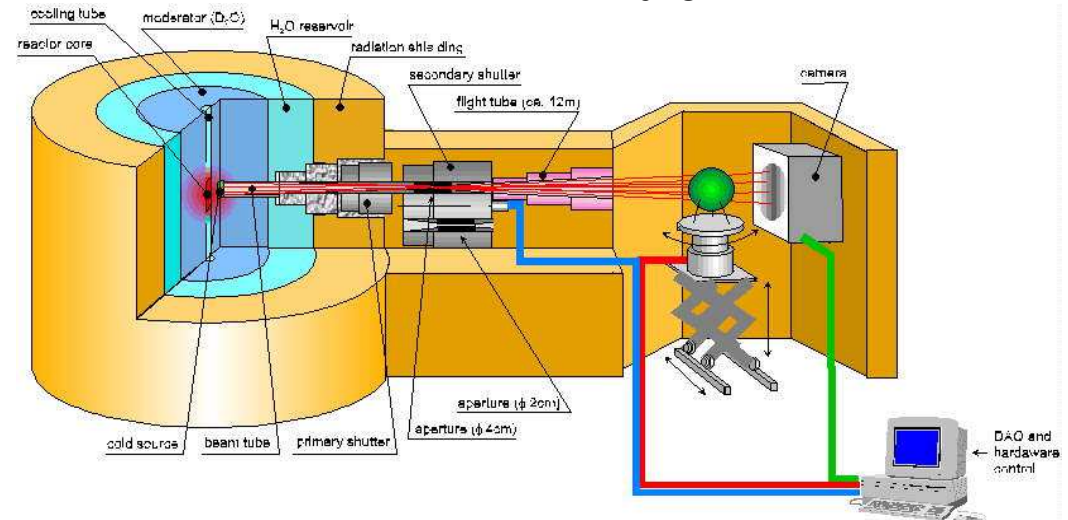


Neutron Imaging Instrumentation – cost

400 MEur



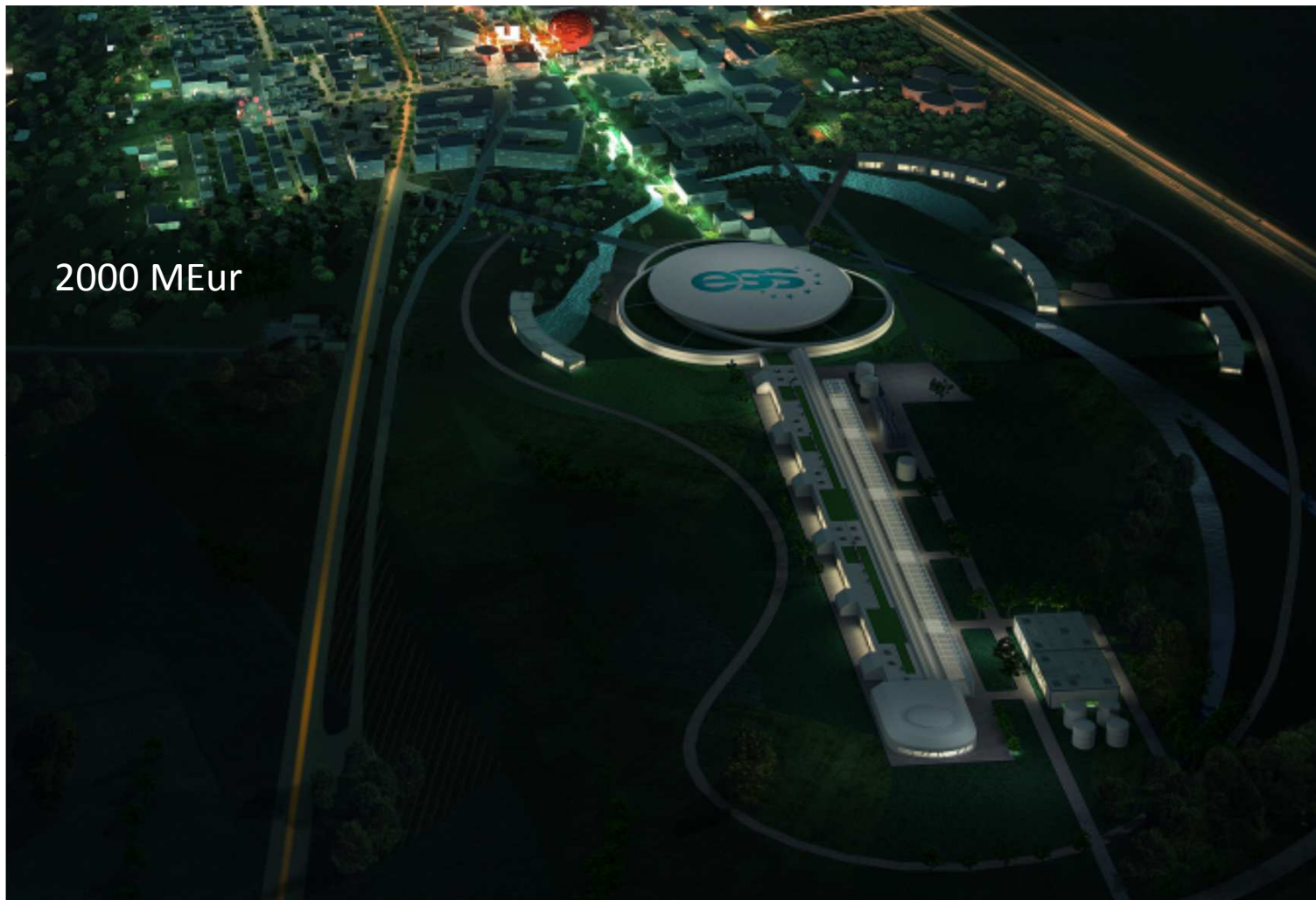
1 MEuro



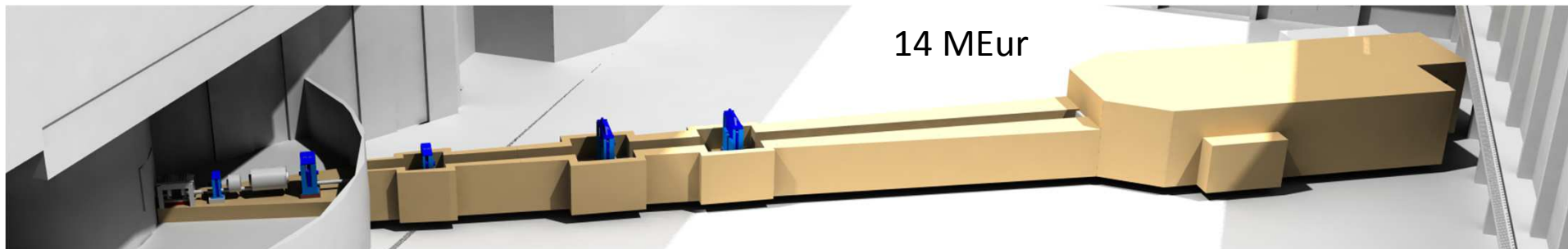


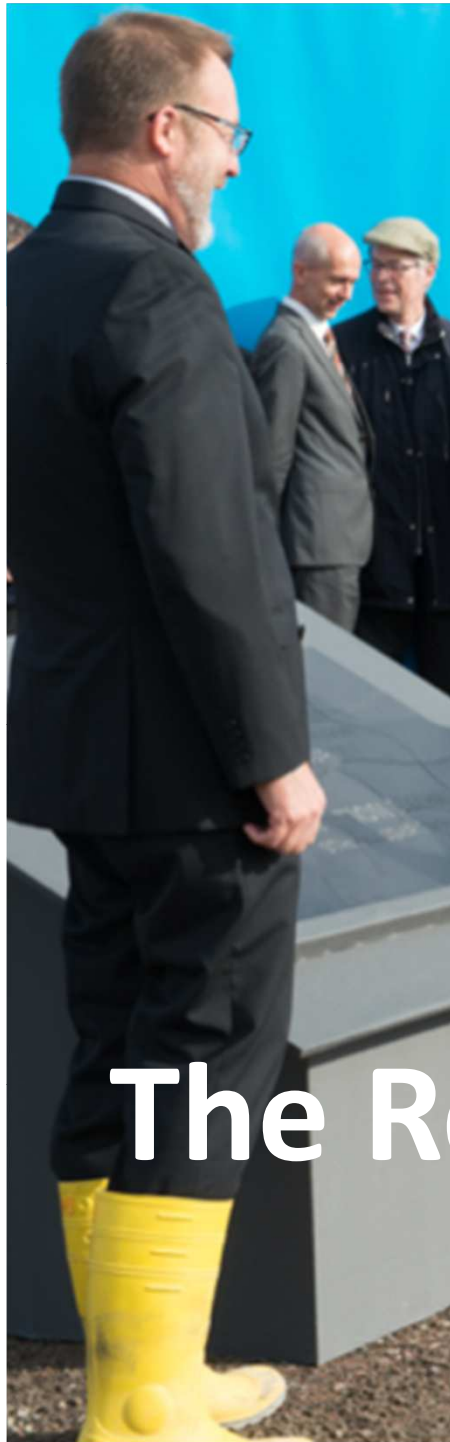
EUROPEAN
SPALLATION
SOURCE

2000 MEur



14 MEur





The R

Now !



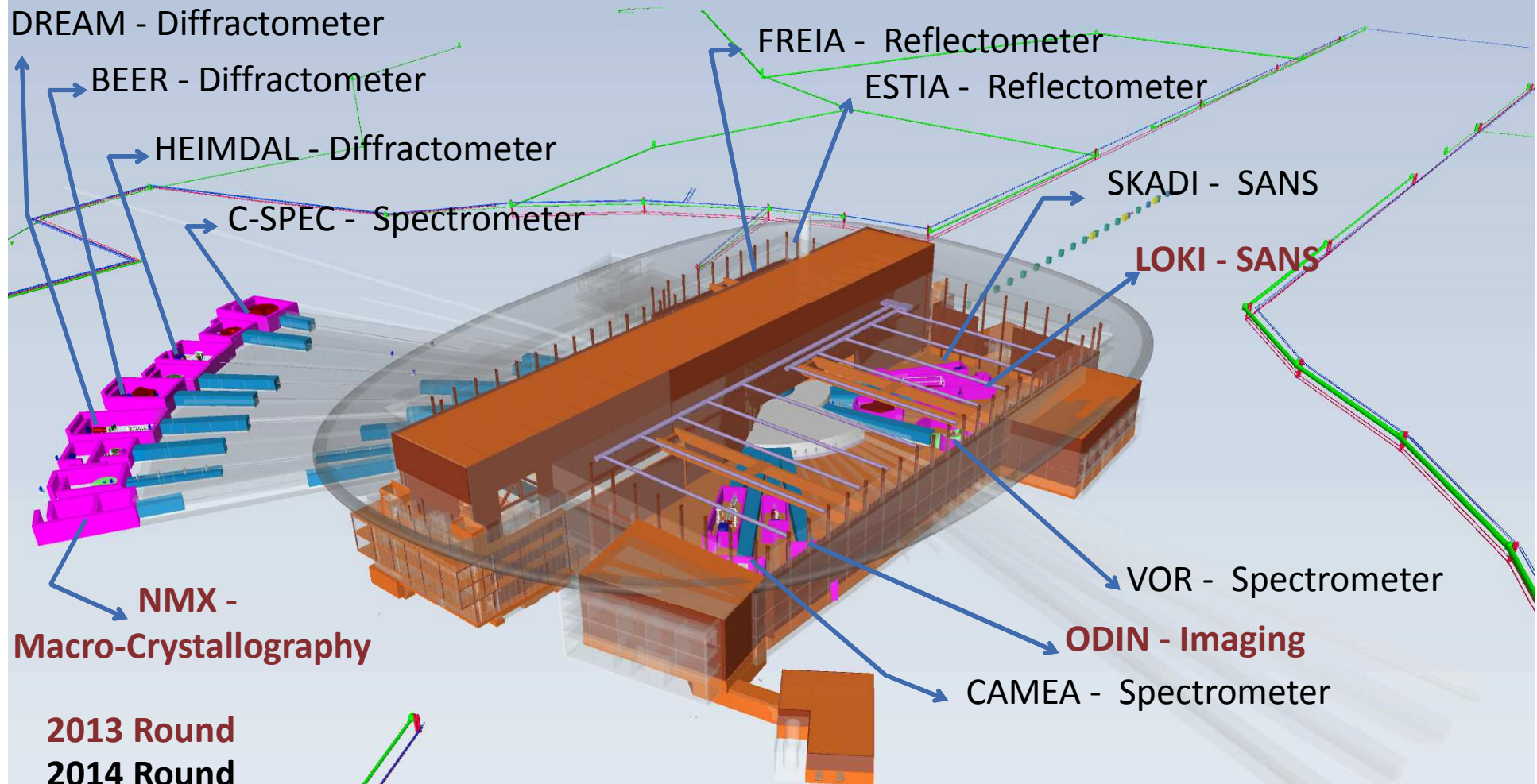
M. Strobl

Deputy Head of Instrument Division
Prof. X-ray and Neutron Imaging Techniques (NBI, KU)

www.europeanspallationsource.se



Instrument Suite and IK Partners



2013 Round
2014 Round